

2023 CAS course on “RF for Accelerators”

RF Measurements

– *Only Part 2* –



Manfred Wendt – CERN

- **CERNBox link:**
<https://cernbox.cern.ch/s/2OHukn46LDn1XOW>

- Printed and updated documentation
- Software (CST and freeware)
- Software examples

Monday, 19 June 2023		Tuesday, 20 June 2023	
08:30	Opening	08:30	Overview cavities I - Frank Gerigk (CERN)
09:30	Theory of EM fields I - Thomas Flisgen (Helmholtz Zentrum Berlin)	09:30	EM simulations I - Thomas Flisgen (Helmholtz Zentrum Berlin)
10:30	Coffee break	10:30	Coffee break
11:00	RF measurements I - Manfred Wendt (CERN)	11:00	RF measurements II - Manfred Wendt (CERN)
12:00	Theory of EM fields II - Thomas Flisgen (Helmholtz Zentrum Berlin)	12:00	EM simulations II - Thomas Flisgen (Helmholtz Zentrum Berlin)
13:00	Lunch	13:00	Lunch

The screenshot shows a CERNBox interface for a folder named "RF measurements I". At the top right, there are icons for link, image, and calendar, along with the date and time "19 Jun 2023, 11:00" and a duration of "1h". Below this, the speaker is identified as "Manfred Wendt (CERN)". A section titled "Presentation materials" contains a list of files: "RFmeasurementsCAS2023.pdf", "RFmeasurementsCAS2023.pptx", and a sub-folder "Documentation" containing "CAS2023_RF_Hands_on_Experiments_latest.pdf", "CAS2023_simulations_latest.pdf", and "CAS2023_Theory_wCover.pdf". On the left side, a file tree lists various CST project files, including folders like "CST_AxelPICexamples", "CST_ButtonPickup", "CST_FD", "CST_ManfredExamples", "CST_modelling", "CST_PICmultipacting", and "Qucs", with numerous individual files such as "Pillbox.cst", "ButtonPickUp_PIC_beta_sweep.cst", "Cavity_eigen.cst", etc.

- **Transmission-lines**
 - TEM lines and (rect.) TE10 waveguides
 - Telegrapher's equation and characteristics: $Z_0, \gamma = \alpha + j\beta$
 - load impedance Z_L , forward / backward traveling waves, reflection coefficient $\Gamma = b/a$
- **Smith chart**
 - Mapping of the complex reflection coefficient and the complex impedance plane
 - Characteristic points and areas in the *Smith* chart
- **Scattering (S)- parameters**
 - Lumped and distributed circuit elements, linear networks described by I - V port parameters
 - n-port networks described by incident (a_i) and reflected / transmitted (b_i) normalized complex voltage waves
 - **Termination of unused ports in their characteristic impedance!**
 - reflection (S_{ii}) and transmission coefficients (S_{ij})
 - S-parameter matrix, properties of S matrices

- **Examples for 1-port S-matrices are any simple, passive (complex) impedances Z**
 - Any R, L, C, RL, RC, LC and RLC circuit or any combinations of those elements leading to a single port network, which of course also may include distributed (transmission-line) elements
 - “Special” cases are:
 - $Z = Z_0 \Rightarrow S_{11} = 0$ (matched, ideal termination)
 - $Z = 0 \Rightarrow S_{11} = -1$ (ideal short)
 - $Z = \infty \Rightarrow S_{11} = +1$ (ideal open)
 - If $|S_{11}| > 1$ an active element is involved, e.g., a reflection amplifier
- $$(S) = S_{11} = Z$$
- **Strictly speaking, a simple RF resonator, e.g., a “pill-box” cavity, is a 3-port**
 - One coaxial or waveguide port as RF power coupler, plus two beam (waveguide) ports.
 - **However, for many practical cases it can be treated as 1-port**
 - The mode of interest, e.g., TM₀₁₀, is trapped with no or negligible fields contribution near the beam-ports
 - We consider only a single coupler to characterize, e.g., the TM₀₁₀ mode in terms of a 1-port S-parameter measurement
 - Typically applying an RLC-parallel equivalent circuit

- **Ideal (matched: $Z = Z_0$) transmission-line of length ℓ**

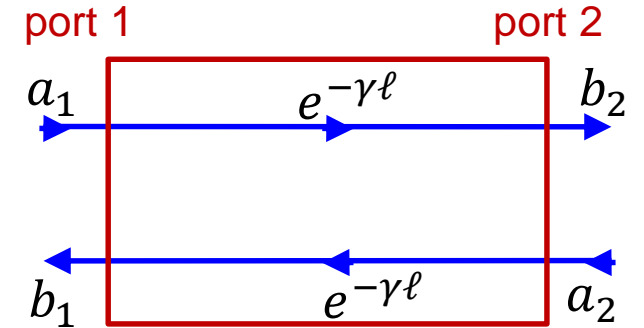
$$(S) = \begin{pmatrix} 0 & e^{-\gamma\ell} \\ e^{-\gamma\ell} & 0 \end{pmatrix}$$

$\gamma = \alpha + j\beta$: propagation constant
 α : attenuation constant in [Np/m]
 $\beta = 2\pi/\lambda$: phase constant [rad/m]

– For a lossless transmission-line: $\alpha = 0 \Rightarrow |S_{21}| = |S_{12}| = 1$

– For a lossless line of length $\ell = \lambda/4$: $(S) = \begin{pmatrix} 0 & -j \\ -j & 0 \end{pmatrix}$

signal flow graph (SFG):



- **Ideal attenuator**

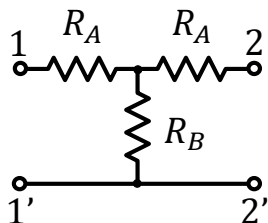
$$(S) = \begin{pmatrix} 0 & k \\ k & 0 \end{pmatrix}$$

$k = V_2/V_1 = 10^{-(\Delta dB/20)}$: attenuation $k < 1, k \in \mathbb{R}$
 $\Delta dB = 20 \log_{10} V_1/V_2$: attenuation in dB
 $\alpha = -\ln k$: attenuation in neper

T-attenuator:

$$R_A = \frac{1-k}{1+k} Z_0$$

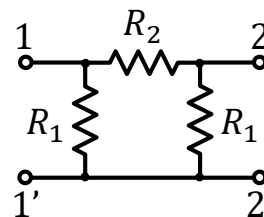
$$R_B = \frac{2k}{1-k^2} Z_0$$



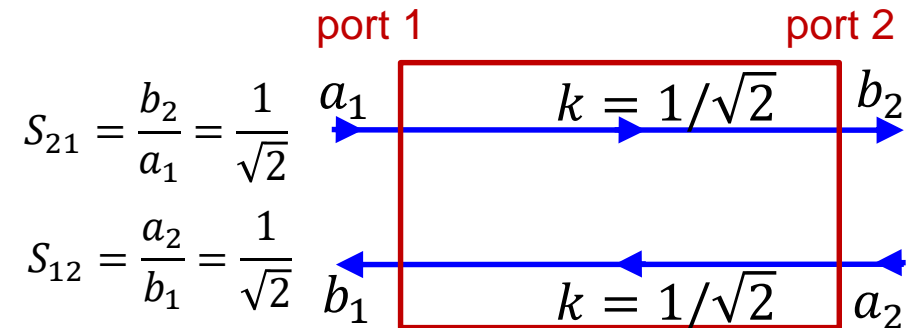
π -attenuator:

$$R_1 = \frac{1-k}{1+k} Z_0$$

$$R_2 = \frac{1-k^2}{2k} Z_0$$



SFG example: 3 dB attenuator



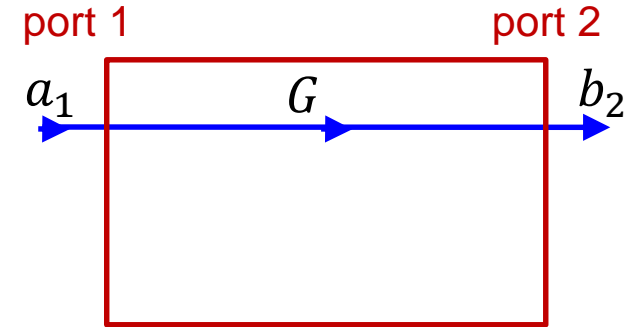
$$S_{21} = \frac{b_2}{a_1} = \frac{1}{\sqrt{2}}$$

$$S_{12} = \frac{a_2}{b_1} = \frac{1}{\sqrt{2}}$$

- **Ideal amplifier (gain stage)**

$$(S) = \begin{pmatrix} 0 & 0 \\ G & 0 \end{pmatrix}$$

$G = V_{out}/V_{in} = 10^{g/20}$: voltage gain $G > 1$
 $g = 20 \log_{10} V_{out}/V_{in}$: voltage gain in dB



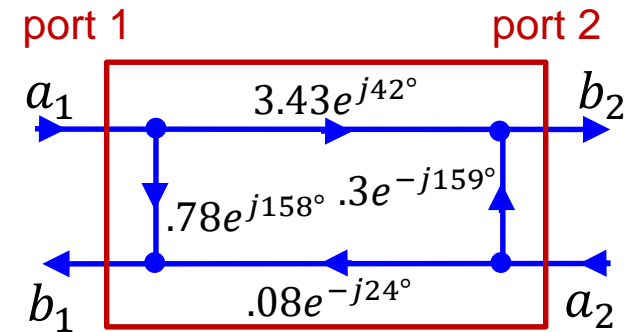
- **Low-noise RF transistor**

$$(S) = \begin{pmatrix} 0.78e^{j158^\circ} & 0.08e^{-j24^\circ} \\ 3.43e^{j42^\circ} & 0.3e^{-j159^\circ} \end{pmatrix}$$

Datasheet Avago VMMK-1218:
 $f = 10 \text{ GHz}$, $Z_0 = 50\Omega$, $T_A = 25^\circ\text{C}$,
 $V_{ds} = 2\text{V}$, $I_{ds} = 20\text{mA}$

- Avago VMMK-1218
- E-pHEMT GaAs FET

- The S-parameters are different at other frequencies and operational conditions
- The transistor requires impedance matching networks at in- and output



- 3-port resistive power divider

$$(S) = \frac{1}{2} \begin{pmatrix} 0 & 1 & 1 \\ 1 & 0 & 1 \\ 1 & 1 & 0 \end{pmatrix}$$

$$b_1 = \frac{1}{2}(a_2 + a_3)$$

$$b_2 = \frac{1}{2}(a_1 + a_3)$$

$$b_3 = \frac{1}{2}(a_1 + a_2)$$

- The transfer-loss between *ij*-ports is 6 dB.

- Ideal circulator

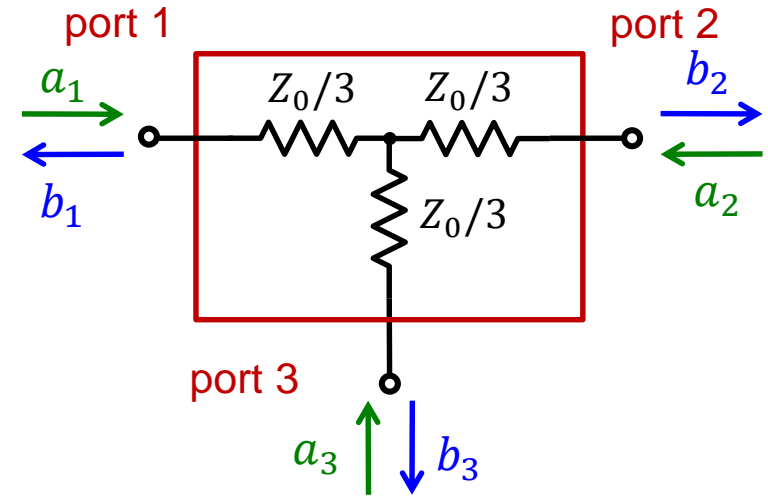
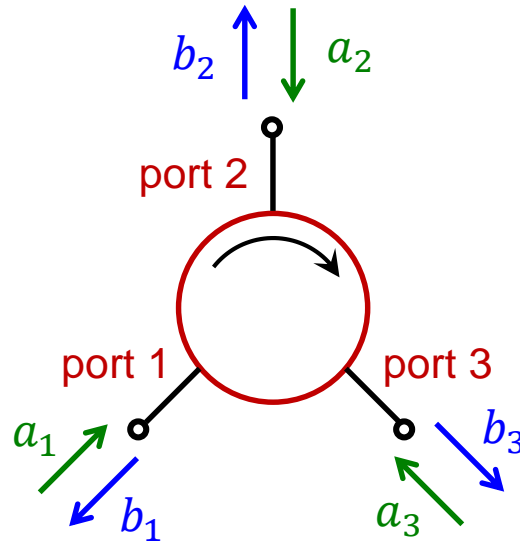
$$(S) = \begin{pmatrix} 0 & 0 & 1 \\ 1 & 0 & 0 \\ 0 & 1 & 0 \end{pmatrix}$$

$$b_1 = a_3$$

$$b_2 = a_1$$

$$b_3 = a_2$$

- Matched, but not reciprocal

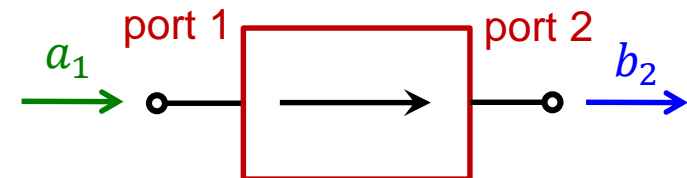


- Isolator, based on the circulator

- Terminating, e.g., port 3 internally results in a 2-port, called **isolator**

$$(S) = \begin{pmatrix} 0 & 0 \\ 1 & 0 \end{pmatrix}$$

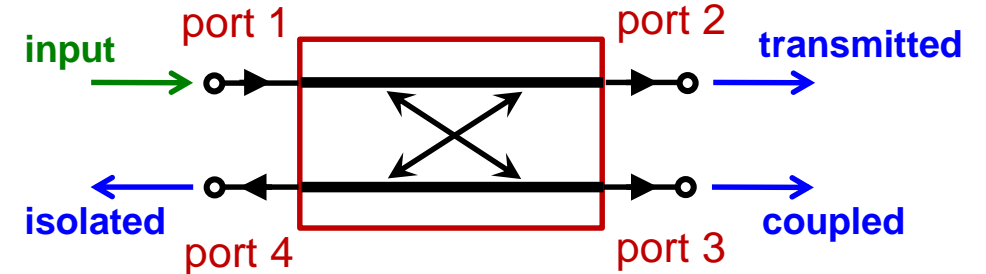
$$b_2 = a_1$$



- **Ideal directional coupler**

coupling coefficient: $k = \left| \frac{b_2}{a_1} \right|$; $\kappa dB = 20 \log_{10} k$

$$(S) = \begin{pmatrix} 0 & -j\sqrt{1-k^2} & k & 0 \\ -j\sqrt{1-k^2} & 0 & 0 & k \\ k & 0 & 0 & -j\sqrt{1-k^2} \\ 0 & k & -j\sqrt{1-k^2} & 0 \end{pmatrix}$$



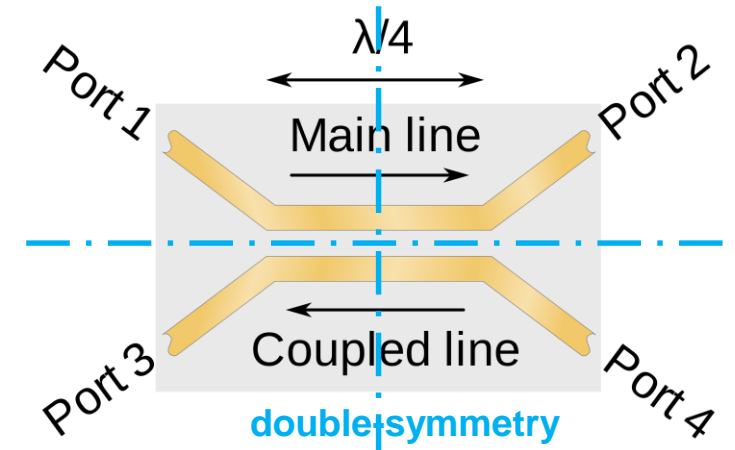
- **Operating at the center frequency**

- **Figures of merit (ideal, lossless):**

- **Coupling factor** $C_{3,1} = \kappa dB = 10 \log_{10}(P_3/P_1)$ [dB]
 - **Insertion loss** $L_{i2,1} = -10 \log_{10}(P_2/P_1)$ [dB]
 - **Coupling loss** $L_{c2,1} = -10 \log_{10}[1 - (P_3/P_1)]$ [dB]
- } no losses:
 $L_{i2,1} = L_{c2,1}$

- **Coupler with losses, imperfections, etc.**

- **Isolation** $I_{4,1} = -10 \log_{10}(P_4/P_1)$ [dB]; $I_{3,2} = -10 \log_{10}(P_3/P_2)$ [dB]
- **Directivity** $D_{3,4} = -10 \log_{10}(P_3/P_4) = -10 \log_{10}(P_4/P_1) + 10 \log_{10}(P_3/P_1)$ [dB]



https://en.wikipedia.org/wiki/Power_dividers_and_directional_couplers

- In practice, **S-parameters are a function of the frequency: $S(f)$**
 - Some instruments or applications can also provide time-domain S-parameters
- In most real-world practical situations, S-parameters are acquired by a measurement, e.g., characterization of a RF component or sub-system by a VNA.
 - By characterizing the DUT over a range of frequencies, $f_{min} < f < f_{max}$ in steps of Δf
- Also, numerical RF analysis tools (Qucs, ADS, Microwave Office, etc.) generate S-parameters through linear RF circuit / systems simulations.
 - Numerical EM software tools (CST, HFSS, etc.) and PCB tools (Cadence Allegro) can also generate S-parameters
- Both application types, VNA measurements and RF/EM simulation software exchange S-parameters on a file basis
 - The *SnP Touchstone* ASCII file format is de-facto the industry standard for S-parameters
 - Example *Touchstone s2p* file:

```

BRSTM_refline_2-4GHz_20001.s2p
!Keysight Technologies,P5024A,MY58100247,A.15.20.07
!Date: Wednesday, October 06, 2021 16:19:17
!Correction: S11(C 2-Port )
!S21(C 2-Port )
!S12(C 2-Port )
!S22(C 2-Port )
!S2P File: Measurements: S11, S21, S12, S22:
# Hz S dB R 50 # format
2000000000 -2.5430779 -88.497566 -18.274168 38.763039 -18.26178 38.742687 -2.4251425 -85.792152
2000100000 -2.5365531 -88.473915 -18.266272 38.606499 -18.269154 38.716461 -2.4215624 -85.861908
2000200000 -2.5314419 -88.471634 -18.280306 38.559021 -18.258684 38.624985 -2.4253747 -85.806236
2000300000 -2.5216722 -88.617905 -18.269596 38.352692 -18.266785 38.342678 -2.4210978 -85.8368
2000400000 -2.5178108 -88.521271 -18.257862 38.298622 -18.275055 38.266792 -2.4244151 -85.914787
2000500000 -2.5327342 -88.484985 -18.263821 38.31945 -18.27046 38.20409 -2.4263382 -85.85775
2000600000 -2.5191193 -88.462044 -18.262426 38.195797 -18.246525 38.250874 -2.3989511 -85.885635
2000700000 -2.5219827 -88.44445 -18.253748 38.216946 -18.245417 38.138355 -2.4155877 -85.859711
2000800000 -2.5198817 -88.588783 -18.255999 37.902744 -18.257757 38.035915 -2.415241 -85.887199
2000900000 -2.5370498 -88.496101 -18.256392 38.004234 -18.258446 37.872906 -2.4170656 -85.854294
2001000000 -2.5363033 -88.544846 -18.252661 37.830475 -18.259445 37.925297 -2.4102871 -85.901245
2001100000 -2.5417418 -88.47406 -18.270754 37.731613 -18.252403 37.74762 -2.4158244 -85.822517
  
```

2-port VNA file

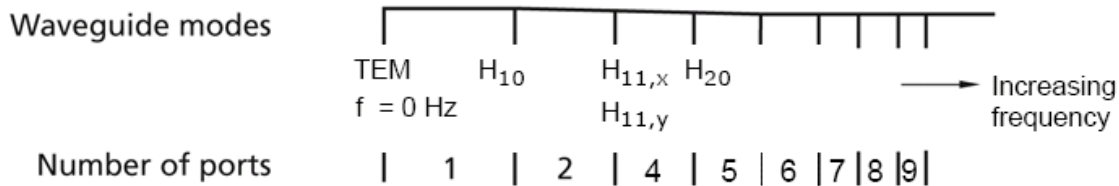
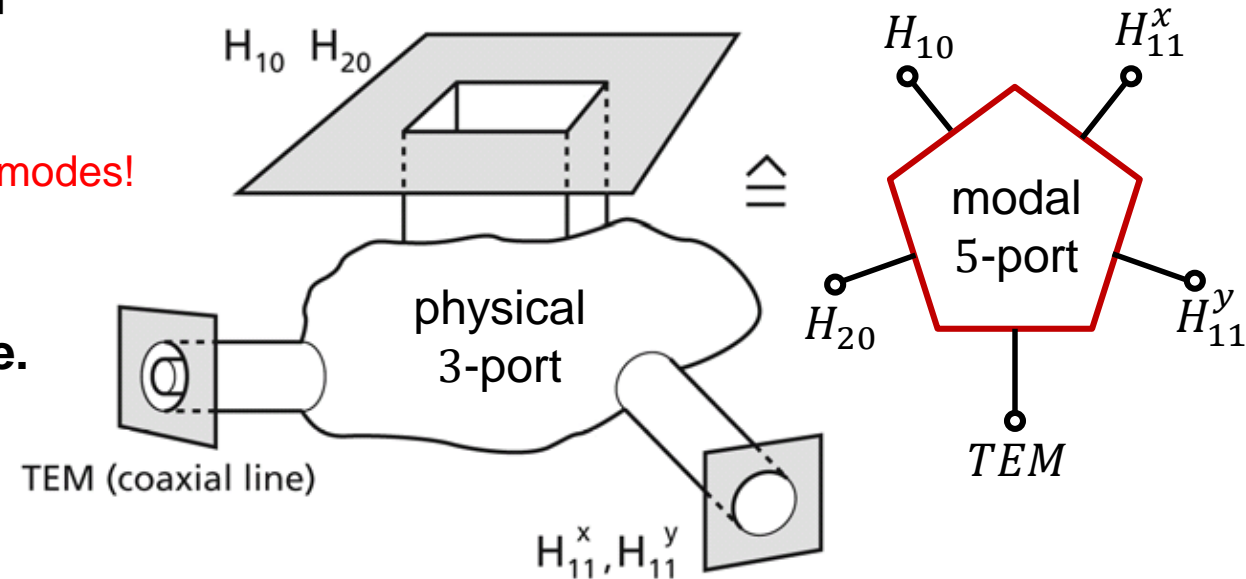
Touchstone v1.1 example file

- v2.0 is different, file ext. *.ts

frequency f $|S_{11}|$ [dB] $\angle S_{11}$ [deg]

- The file name extension specifies the number n of ports
 - Attention: NOT equal to the number of columns! The carriage return (CR) is different between s1p, s2p and s3p, s4p files!
- The comment header (!) includes general information, e.g., type of instrument, measurement time, etc.
- The format line (#) defines the format (mag[dB],angle[deg], mag/angle, real/imag), stimulus units and the reference impedance
- The column delimiter varies, e.g., space, comma, semicolon, etc.
 - Column order in the example file: f $S11dB$ $S11a$ $S21dB$ $S21a$ $S12dB$ $S12a$ $S22dB$ $S22a$

- A general n -port may include ports of different technologies, i.e., waveguides, as well as TEM transmission-lines, such as coaxial lines, microstrip lines etc.
 - In the frequency range of interest different modes may propagate at each physical port, e.g., several waveguide modes in a rectangular waveguide and/or higher order modes in a coaxial line..
 - Each EM-mode must then be represented by a distinct modal port.
 - This is very important in EM-simulation to ensure the absorption of the energy for all modes!
 - The number of modal ports needed generally, increases with frequency, as more waveguide modes can propagate.



H_{11}^x, H_{11}^y : x, y -polarization of the E_{11} circular mode

- The scattering (**S**) parameters are based on incident and reflected normalized complex voltage waves (power waves), defined at the ports of a RF network.
- **S-Parameters** are used to characterize a linear, time-invariant RF component, circuit or sub-system as function of frequency under realistic operational conditions
 - The **S-parameters** are given in a matrix notation, and have complex values
- The characteristic of the **S-matrix** may provide additional details about the network, such as reciprocity, symmetry, losses.
- Typically, the **S-parameters** matrix of a RF network is acquired by measurement characterization with a vector network analyzer (VNA), or by a numerical analysis, e.g., circuit analysis or electromagnetic simulation software
- The **S-parameter** matrices of a set of networks can be converted to transfer (**T**) parameter matrices to enable a simple cascading of those networks
- The number of logical, modal ports might be higher than the number of physical ports for a general RF network utilizing various transmission-line technologies.

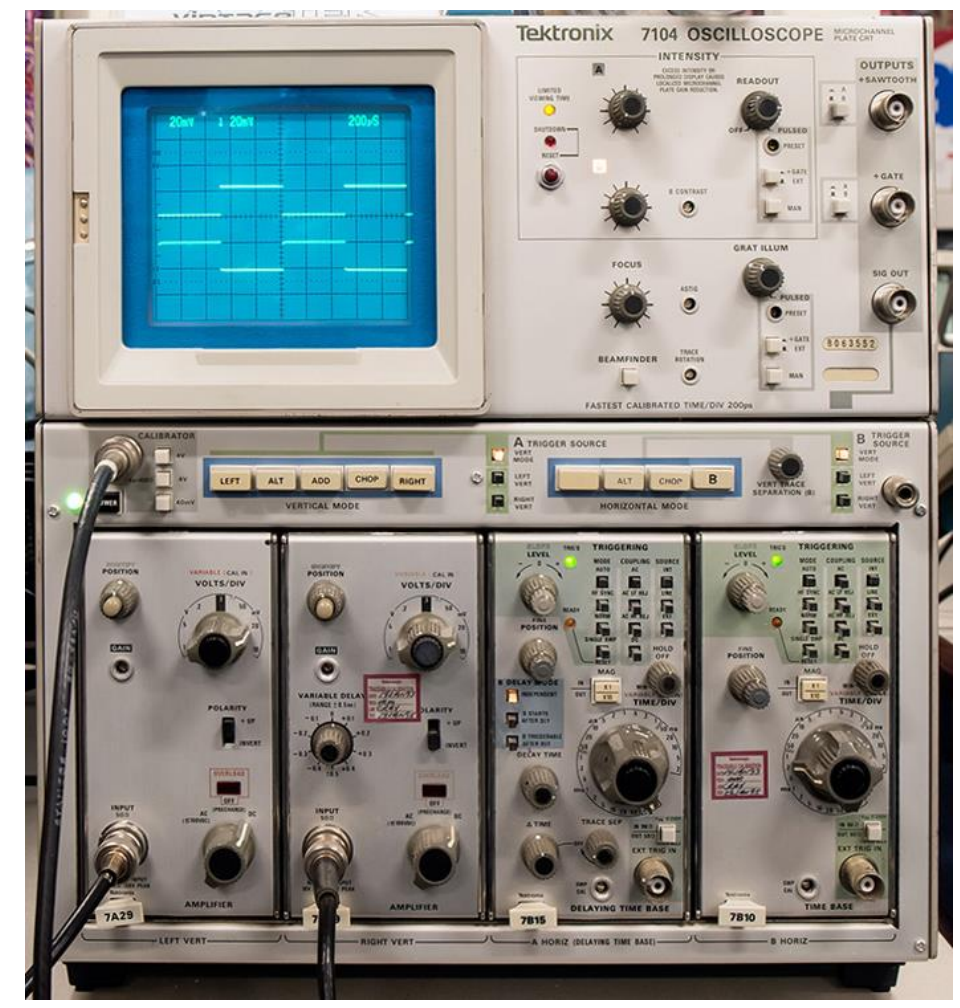
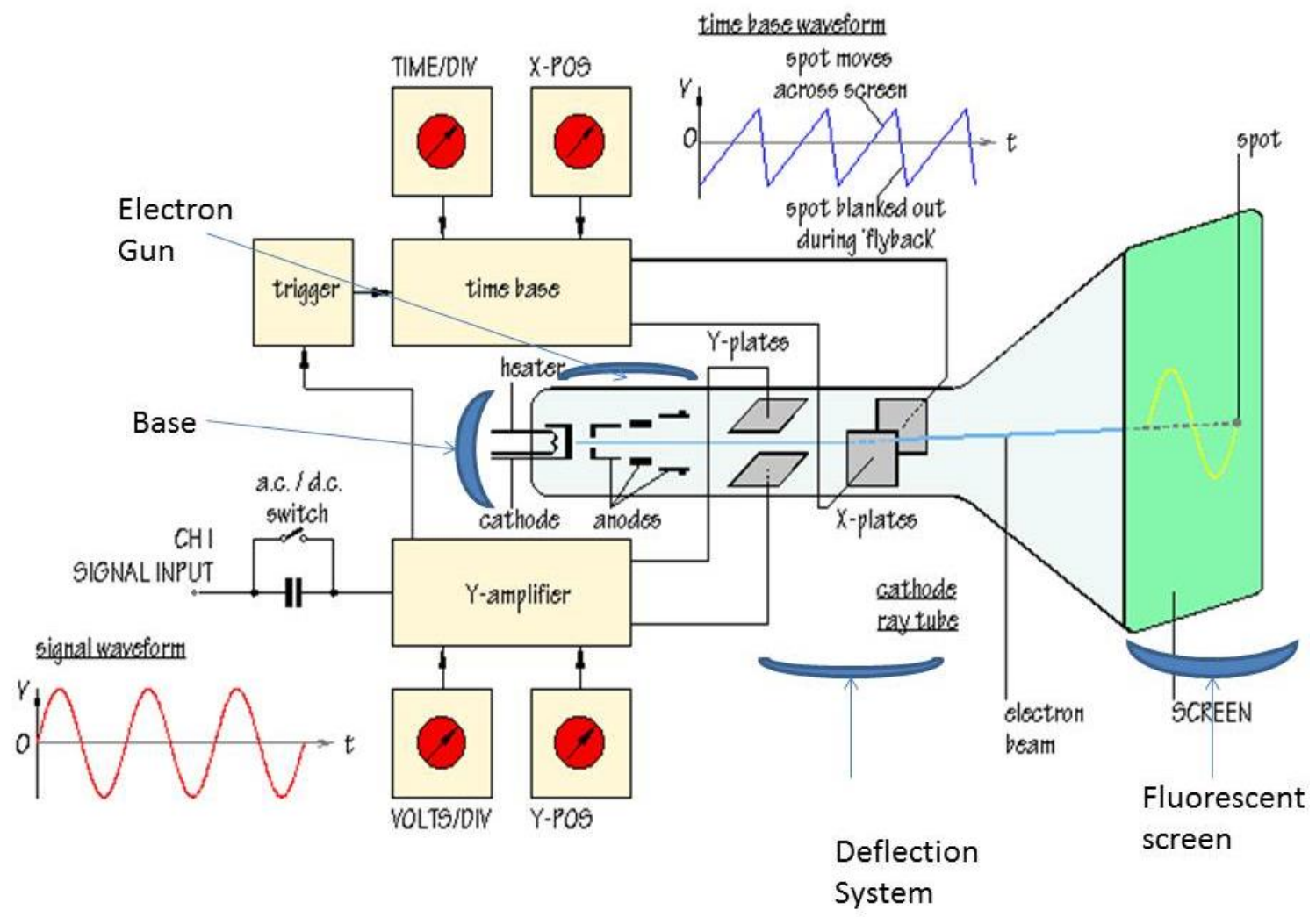
- **Overview of RF measurement instruments**
 - Oscilloscope, spectrum analyzer (SA), signal (FFT) analyzer, slotted measurement line, vector network analyzer (VNA)
- **The super-heterodyne receiver principle**
 - Modulation, down-conversion, mixer, spectrum analyzer block schematics
- **Reflection measurement with the slotted coaxial air-line**
- **S-parameter measurements**
 - Simple measurement setup, VNA block schematics
 - VNA calibration
 - Features of modern RF measurement equipment
 - Synthetic pulse measurements with the VNA
 - **Measurement example: pillbox resonator characterization**
 - Equivalent circuit parameters, Q -factor measurement in the *Smith*-chart, R/Q measurement
 - **Measurement of the beam-coupling impedance with a stretched-wire**

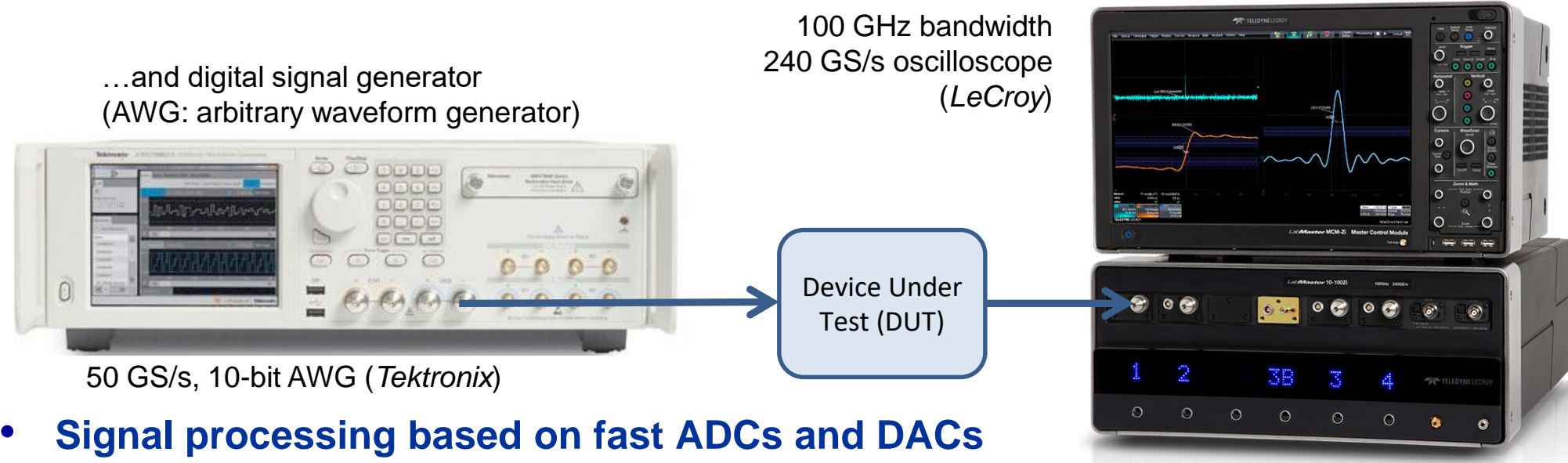
There are different options to observe RF signals

Here some typical measurement tools:

- **Oscilloscope**: to observe signals in **time-domain**
 - periodic signals
 - burst and transient signals with arbitrary waveforms
 - application: direct observation of signals from a beam pick-up, from a test generator, or from other sources
 - visualizes the shape of a waveform, etc.
 - limited performance for the evaluation of non-linear effects.

Cathode Ray Tube (CRT) Oscilloscope





- **Signal processing based on fast ADCs and DACs**
 - **Similar “look and feel” as analog oscilloscopes, but better performance**
 - 8...12-bit multi-GS/s ADCs, still, be aware of aliasing effects!
 - Fast sampling oscilloscope require sufficient memory resources.
- **AWG or pulse generator & digital oscilloscope:**
Time-domain (TD) test setup
 - **Device under test (DUT) characterization and trouble shooting**
 - Impulse, step, or arbitrary waveform (e.g., beam signal) as stimulus signal
 - High impedance probe for measurements on the printed circuit board (PCB)

- **Spectrum analyzer**: to observe signals in a “frequency-domain like” fashion
 - sweeps in equidistant steps through a given frequency range
 - application: observation of spectrum from the beam, or from a signal generator or RF source, or the spectrum emitted from an antenna to locate EMI issues in the accelerator tunnel, etc.
 - Also, DUT characterization in the laboratory, e.g., noise figure measurement on amplifiers (requires a noise source), intermodulation measurements on amplifiers (requires two RF generators).
 - Requires periodic signals
 - Assumes **time-invariance** of the measurement object (DUT) throughout the frequency sweep
 - **Large dynamic range!**
- **RF detection (Schottky) diode (RF power meter)**
 - Supplies a rectified (video) output signal proportional to the RF signal level
 - Delivers no frequency or phase information but operates over a very broad frequency range few MHz to many GHz, and up to 90 dB dynamic range.

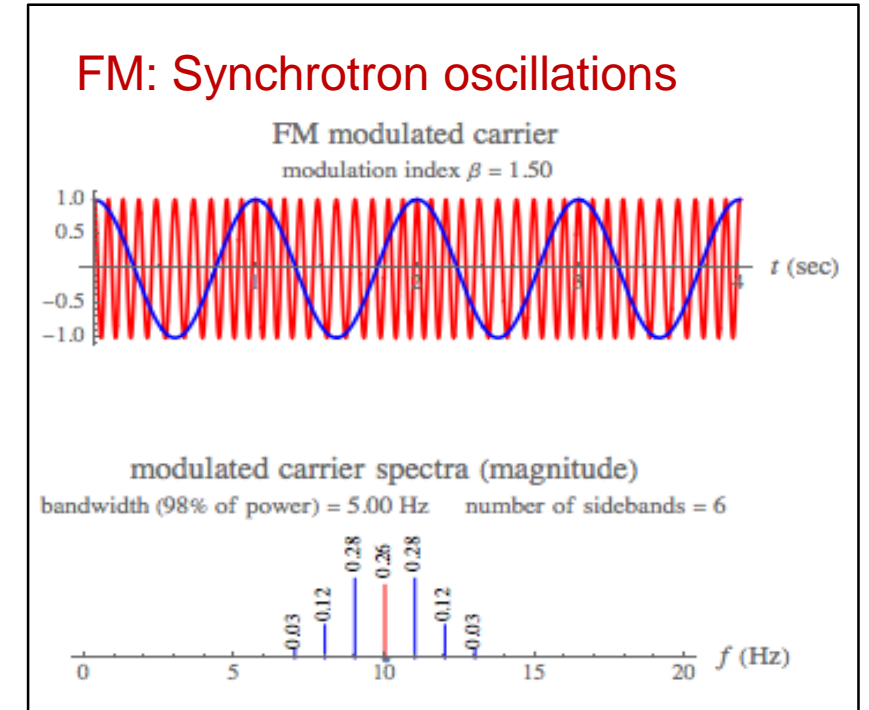
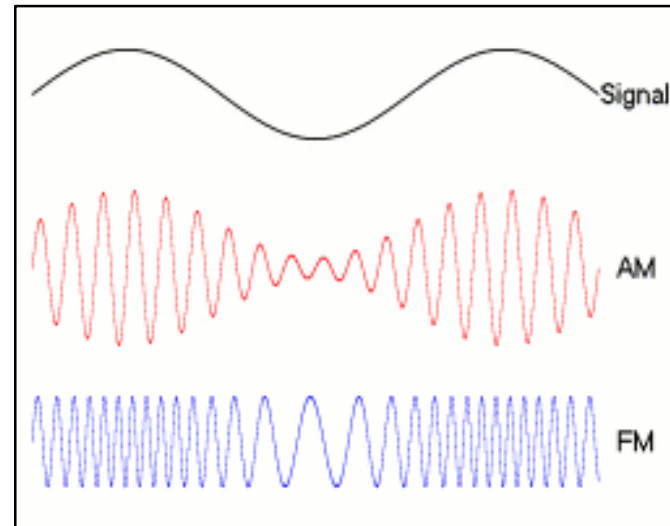
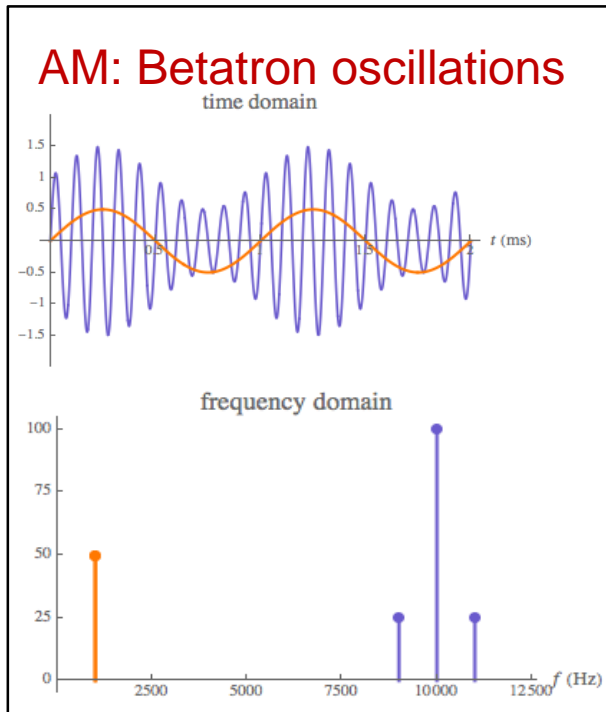
- **Vector signal analyzer (VSA), sometimes called FFT analyzer**
 - Acquires the RF signal, after down-conversion to an intermediate (IF) signal, in time-domain by fast sampling
 - Further numerical treatment in digital signal processors (DSPs)
 - Spectrum calculated using Fast Fourier Transform (FFT)
 - Combines **features of an oscilloscope and a spectrum analyzer**: Signals can be observed directly in time-domain, or in a frequency-domain like fashion
 - Contrary to the SA, also the spectrum of non-periodic signals and transients can be measured
 - Application: Observation of tune sidebands, transient behavior of a phase locked loop, single pass beam signal spectrum, etc.
 - **Digital oscilloscopes** and **FFT analyzers** share similar technologies, i.e., fast sampling and digital signal processing, and therefore can provide similar measurement options
 - The digital oscilloscope directly digitizes the RF signal
 - limited dynamic range, large instantaneous bandwidth
 - The FFT analyzer digitizes the down-converted IF signal
 - large dynamic range, but (still) limited instantaneous bandwidth

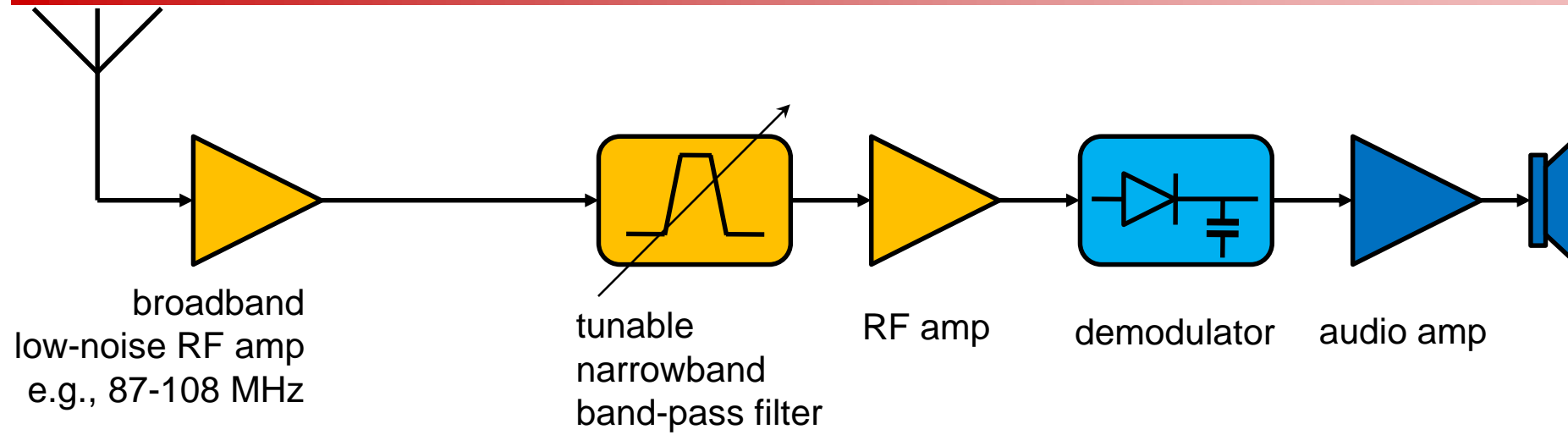
Tools to characterize RF components and sub-systems:

- **Slotted coaxial (or waveguide) measurement transmission-line**
 - For study and illustration purposes only – not anymore used in today's RF laboratory environment.
- **Vector Network Analyzer (VNA)**
 - Combines the functions of a vector spectrum analyzer (FFT analyzer), a RF sweep generator, and a S-parameter test set (directional coupler)
 - Excites a *Device Under Test* (DUT, e.g., circuit, antenna, amplifier, etc.) network at a given sinusoidal *continuous wave* (CW) frequency, and measures the response in magnitude and phase => **determines the S-parameters**
 - Covers a selectable frequency range by measuring step-by-step at subsequent frequency points (like a spectrum analyzer, again requires the DUT to be time-invariant!)
 - Applications: characterization of passive and active RF components, *Time Domain Reflectometry* (TDR) by Fourier transformation of the reflection response, etc.
 - Also, power sweep measurements (1 dB compression point), 4-port VNAs enable virtual ports: e.g., single-ended / differential port DUT characterization.
 - **The VNA is the most versatile and comprehensive tool in the RF laboratory!**

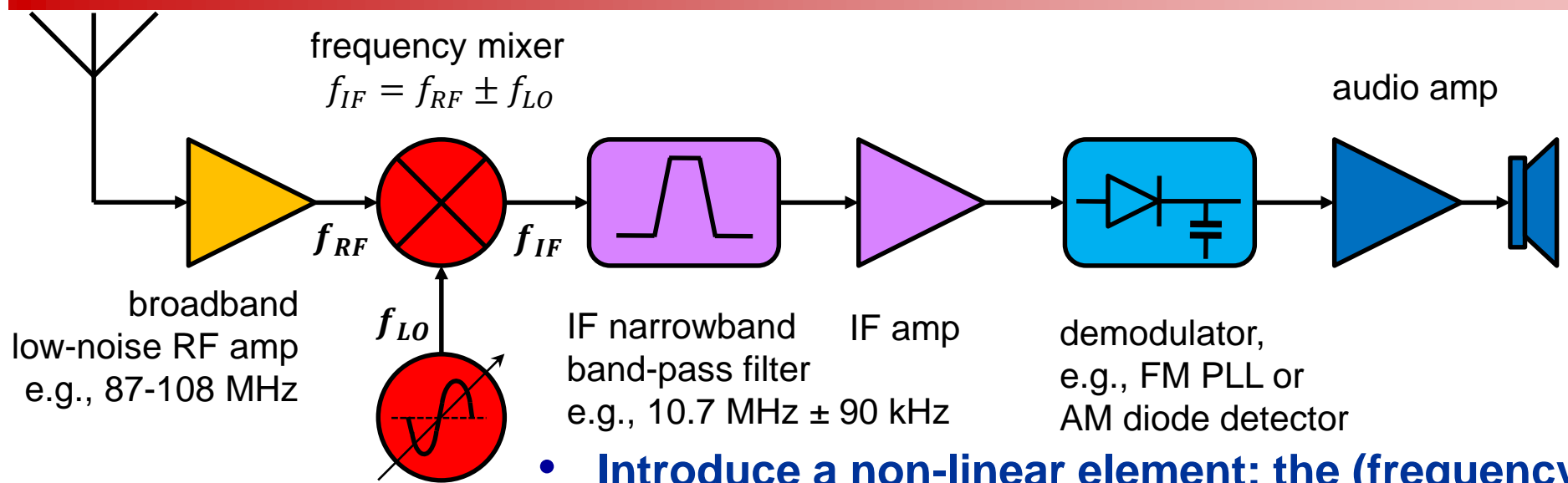
RF Signals & Modulation, without Math!

- RF signals are continuous wave (CW), sinusoidal signals
 - Often, a high frequency carrier is **modulated** with low frequency information
 - Modulation appears “naturally” in ring accelerators as:
 - Modulation is also provided through the LLRF system to the accelerating structures





- **...or: How does a "traditional" analog radio works?**
 - It was, and still is, difficult to make precisely tunable narrowband, band-pass filters for high frequencies (~100 MHz)!!
 - high frequency low-noise amplifiers are expensive!
 - high frequency demodulators are not trivial.
 - **direct detection of radio and RF signals is challenging!**



- **Introduce a non-linear element: the (frequency) mixer!**
 - ”down-convert” the RF band to a fixed ”intermediate” frequency (IF): $f_{IF} = f_{RF} \pm f_{LO}$
 - requires a tunable local oscillator (LO)
 - well manageable IF section:
 - narrowband band-pass filter(s) (BPF) and amplifier(s)
 - RF telecommunication standard
 - Often multiple mixing stages are used in modern RF instruments, e.g., spectrum and network analyzers

$$y_{RF}(t) = A_{RF} \sin(\omega_{RF}t + \varphi_{RF})$$

RF →

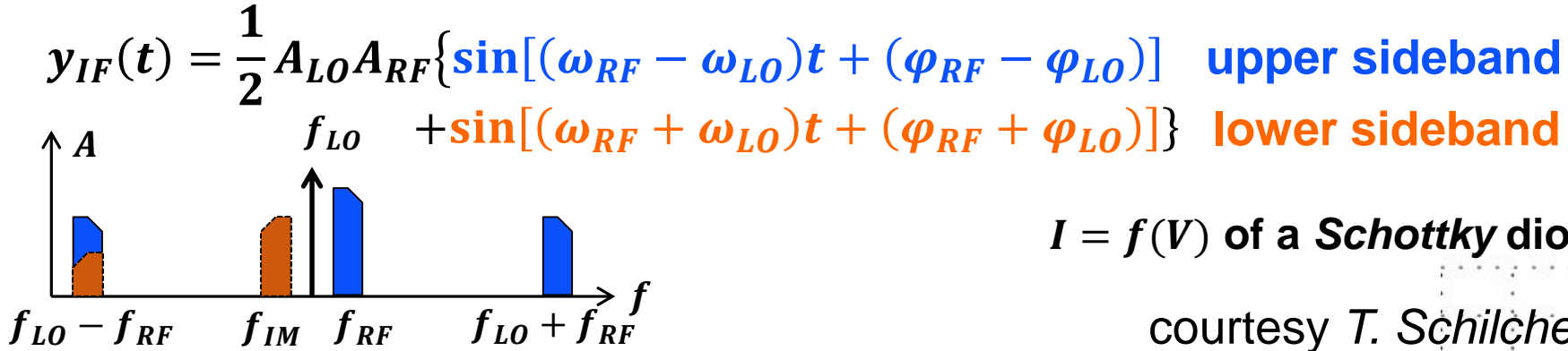
→ IF

$$y_{IF}(t) = y_{RF}(t)y_{LO}(t)$$

↑ LO

$$y_{LO}(t) = A_{LO} \sin(\omega_{LO}t + \varphi_{LO})$$

- **Ideal mixer:** $f_{IF} = f_{RF} \pm f_{LO}$



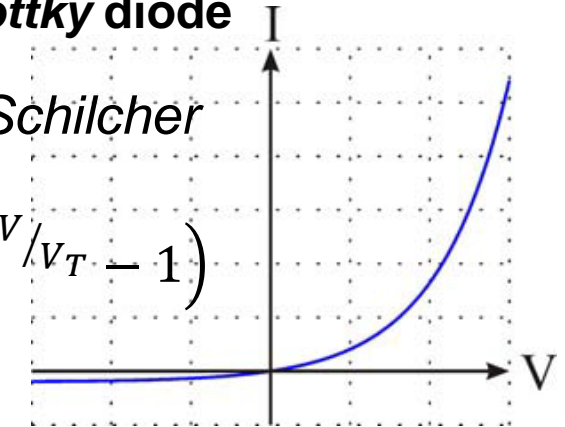
- **Frequency conversion**
 - $f_{RF} \neq f_{LO}$: heterodyne receiver
 - $f_{RF} = f_{LO}$: homodyne, demodulator

- **Real-world mixer:** $f_{IF} = m f_{RF} \pm n f_{LO}$
 - **Image frequency:** $f_{IM} = f_{LO} - f_{IF}$

$I = f(V)$ of a Schottky diode

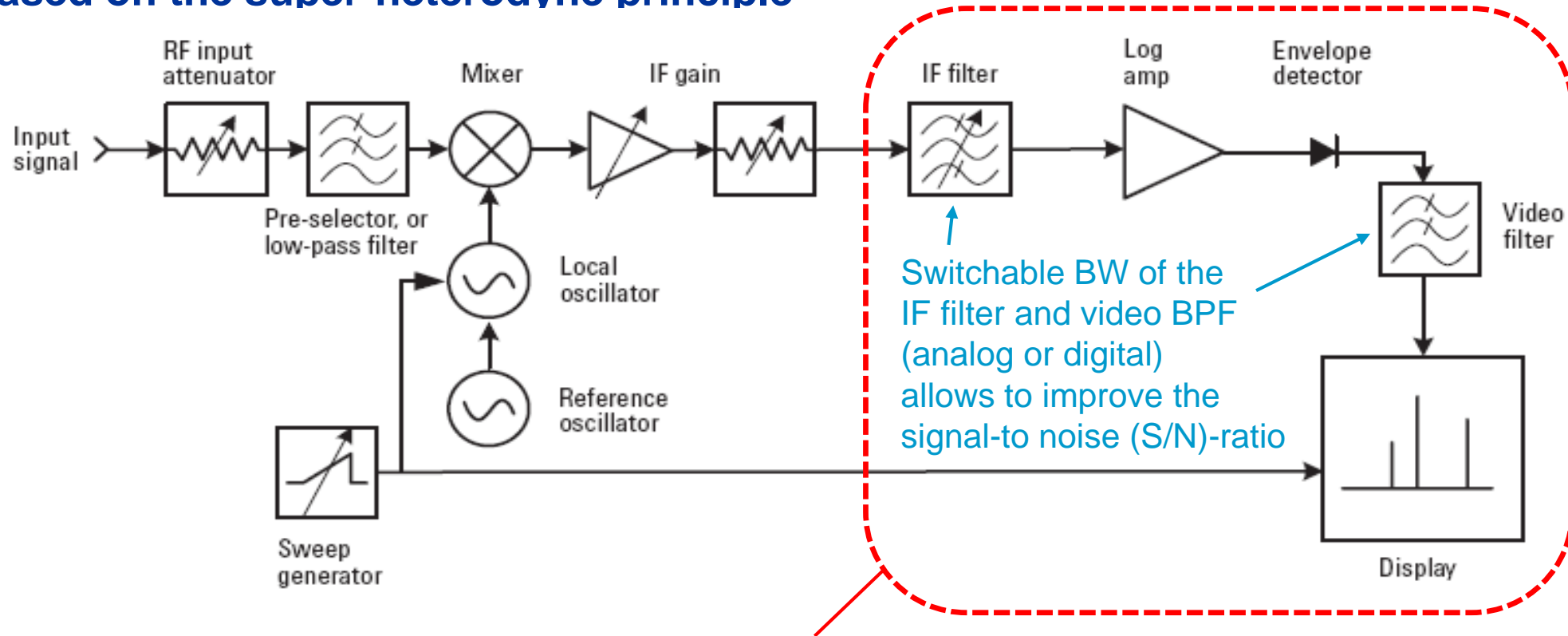
courtesy T. Schilcher

$$I = I_0 \left(e^{V/V_T} - 1 \right)$$



$$\Delta I = I_0 e^{V/V_T} \left[\frac{\Delta V}{V_T} + \frac{1}{2} \left(\frac{\Delta V}{V_T} \right)^2 + \frac{1}{6} \left(\frac{\Delta V}{V_T} \right)^3 + \dots \right]$$

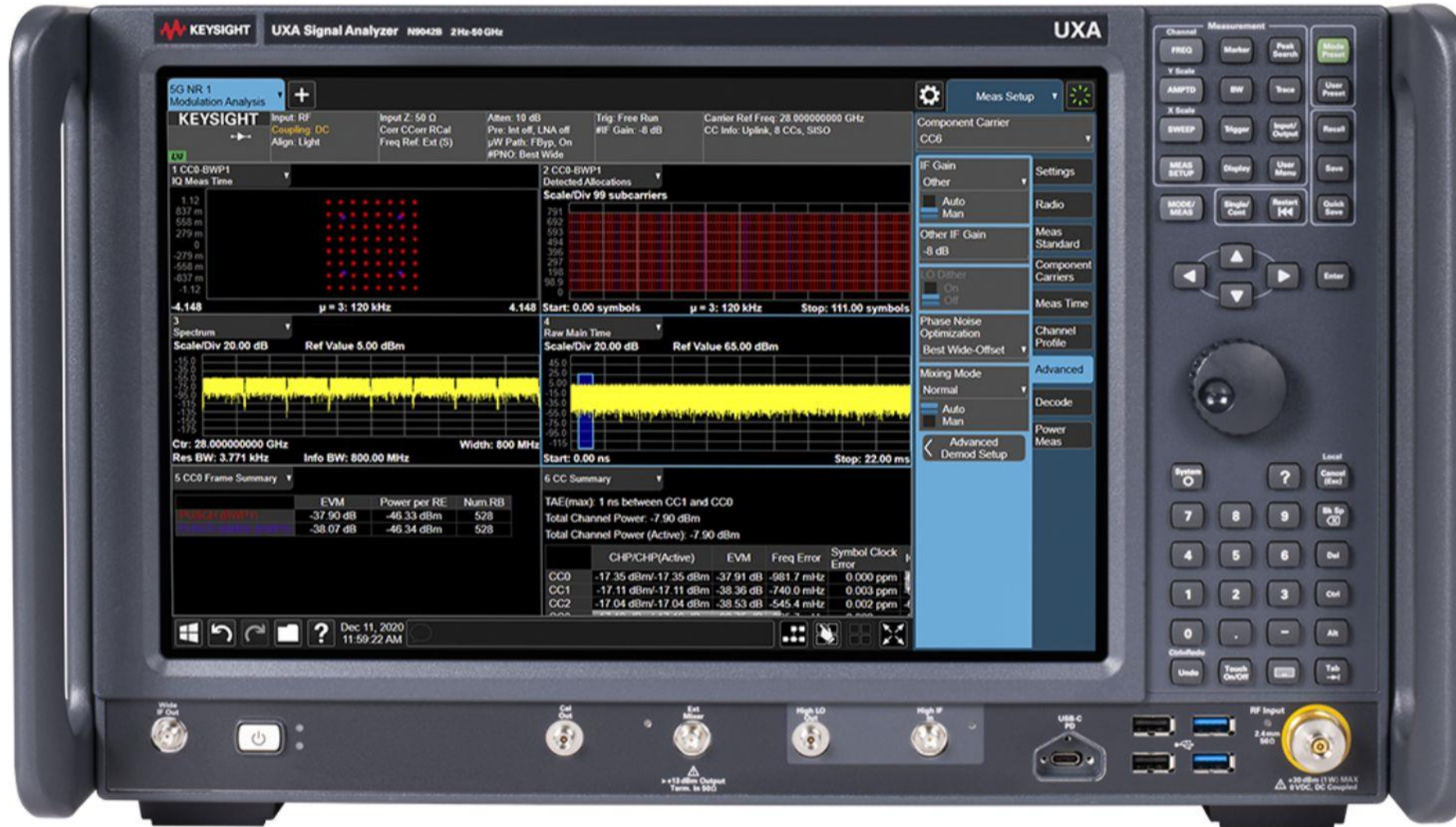
- based on the super-heterodyne principle

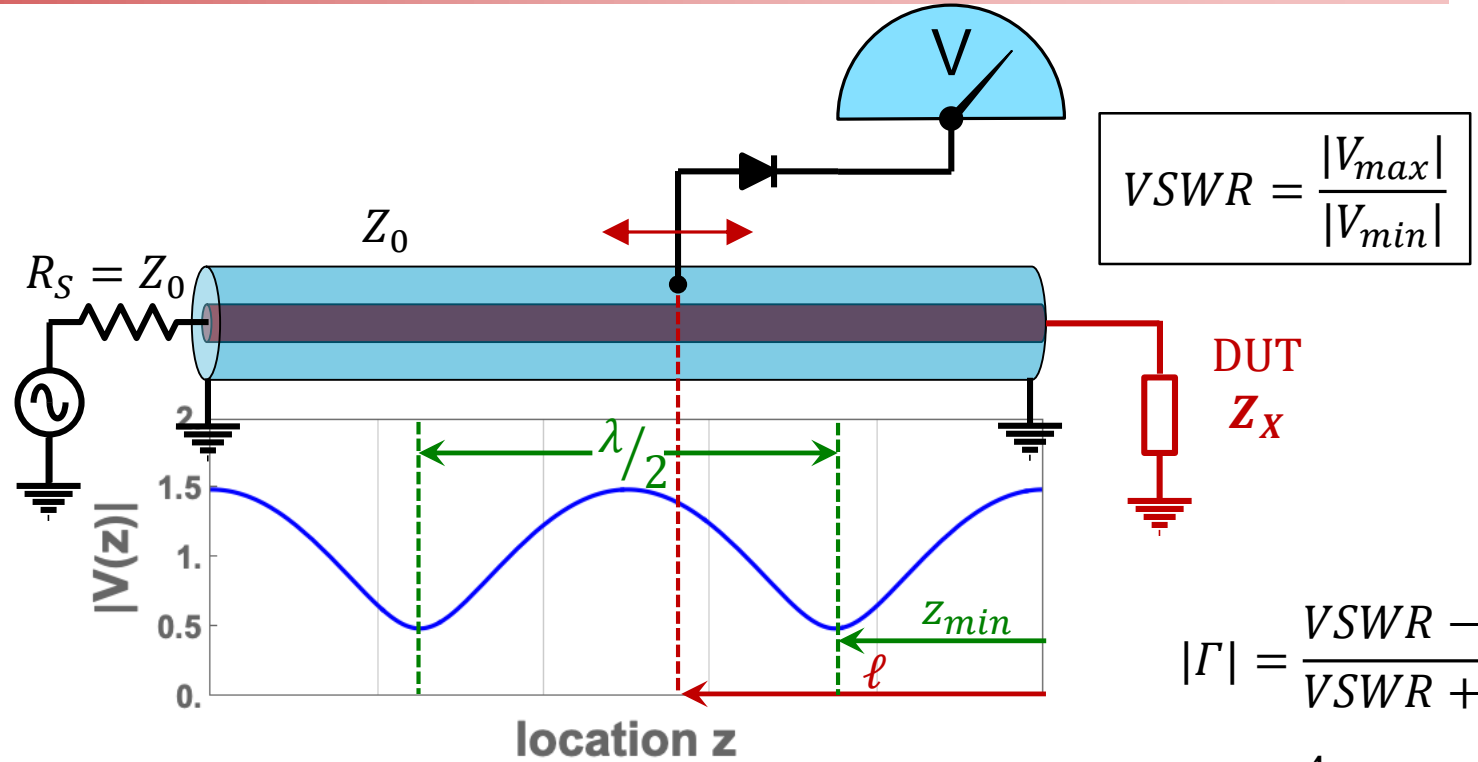
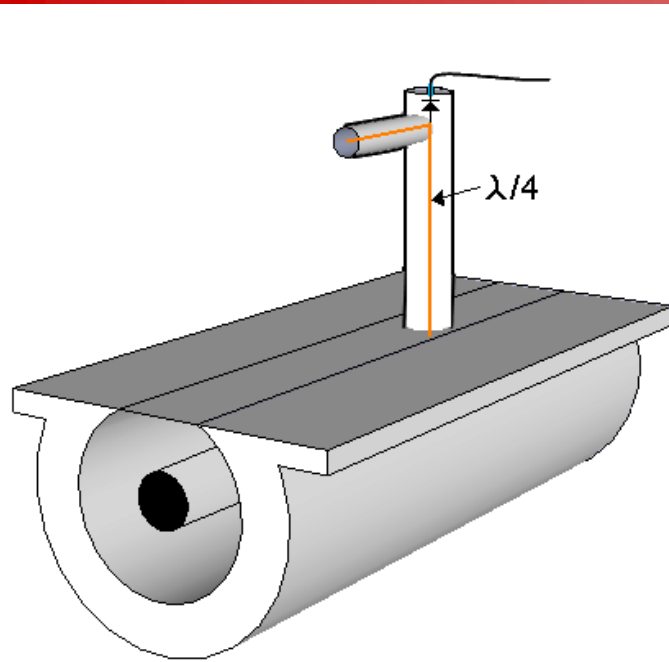


Today, the IF, demodulation, video and display sections of a spectrum analyzer are realized **digitally**

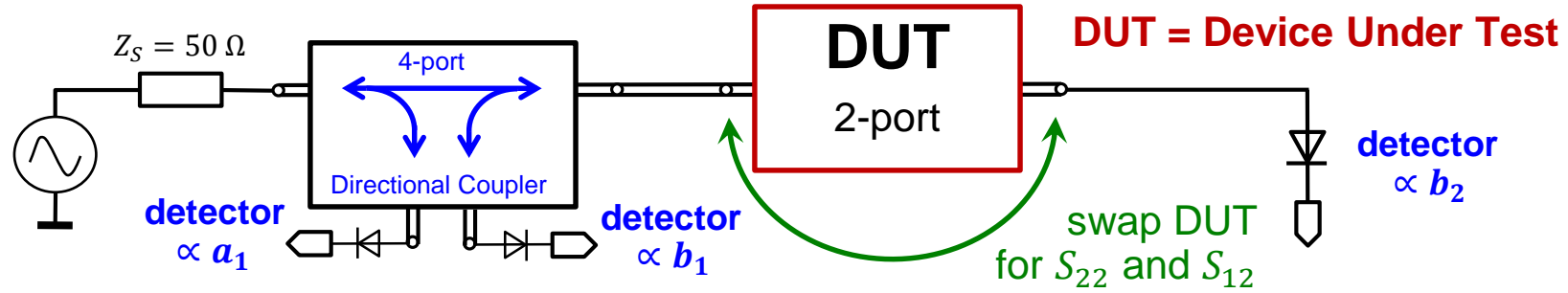
- Requires an analog-digital converter (ADC) with sufficient dynamic range

Modern Spectrum (RF Signal) Analyzer





- **Slotted coaxial air-line** is used as standing wave detector
 - Probes the radial **electric field** along the slotted line.
 - Measurement of E-field **minima's** E_{min} and **maxima's** E_{max} with a diode detector, thus detect $|V_{min}|$ and $|V_{max}|$ along the line.
 - Evaluate the **reflection coefficient** Γ of a **DUT of unknown** Z_X at the end of the line

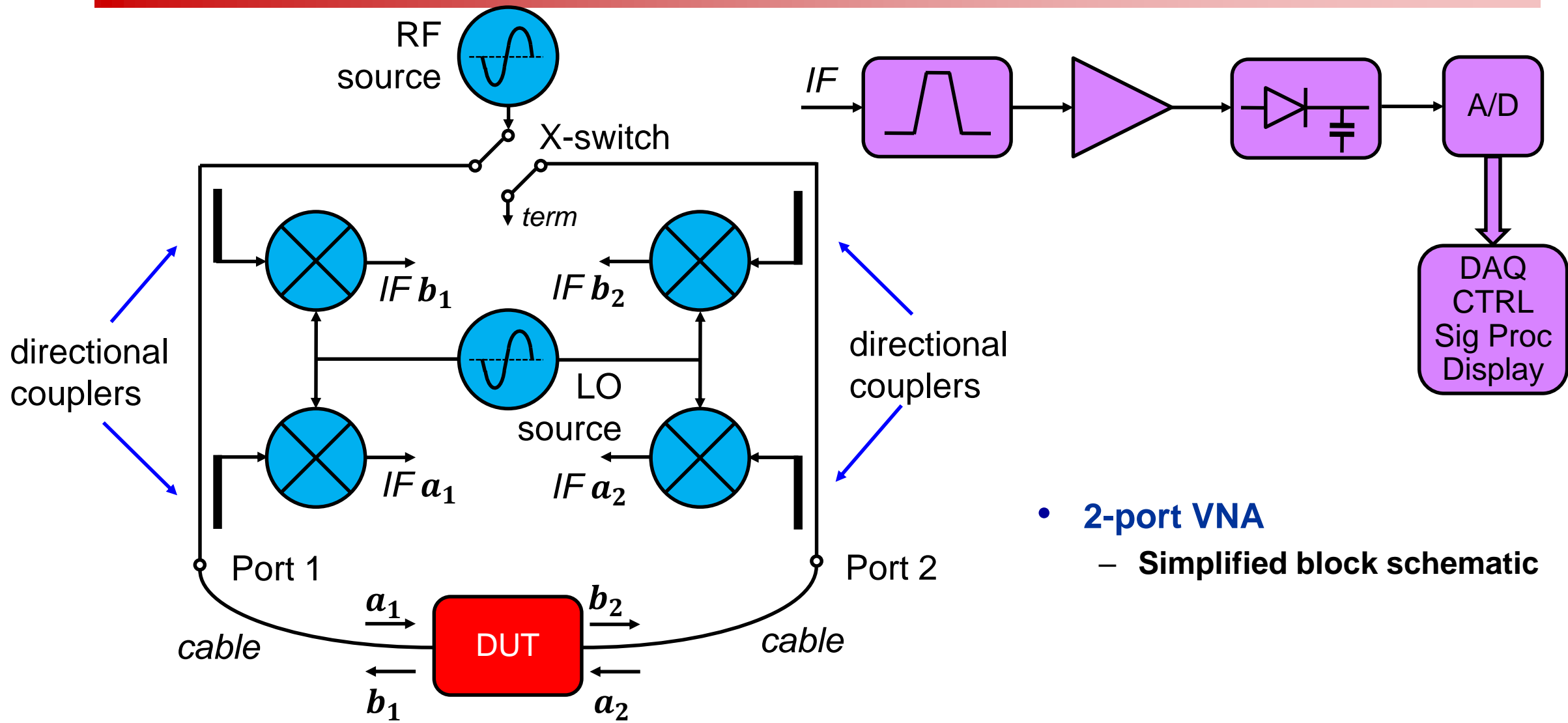


- **Performed in the “frequency domain”**
 - Single or swept frequency generator, stand-alone or as part of a VNA or SA
 - Requires a **directional coupler** and RF detector(s) or receiver(s)
- **Evaluate S_{11} and S_{21} of a 2-port DUT**
 - Ensure $a_2 = 0$, i.e., the detector at port 2 offers a well-matched impedance
 - Measure incident wave a_1 and reflected wave b_1 at the directional coupler ports and compute for each frequency
 - Measure transmitted wave b_2 at DUT port 2 and compute
- **Evaluate S_{22} and S_{12} of the 2-port DUT**
 - Perform the same methodology as above by exchanging the measurement equipment on the DUT ports

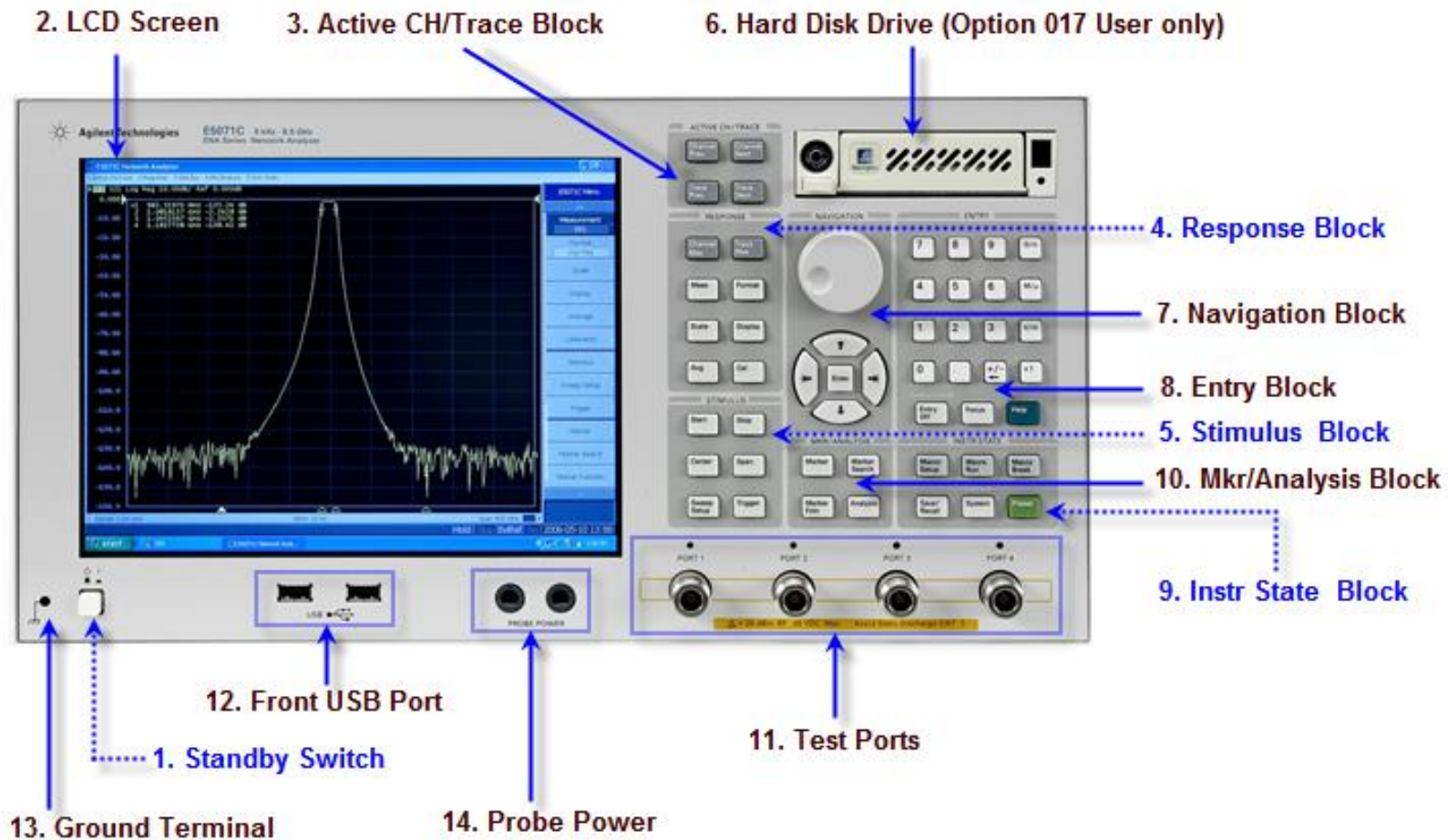
$$S_{11} = \left. \frac{b_1}{a_1} \right|_{a_2=0}$$

$$S_{21} = \left. \frac{b_2}{a_1} \right|_{a_2=0}$$

The Vector Network Analyzer (VNA)

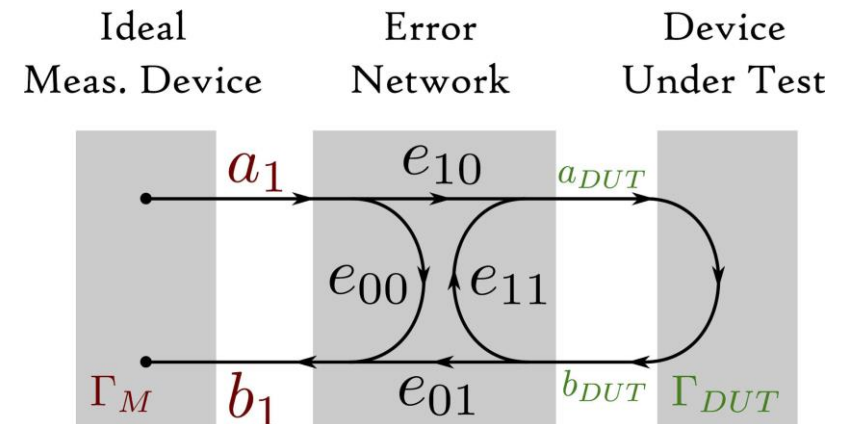


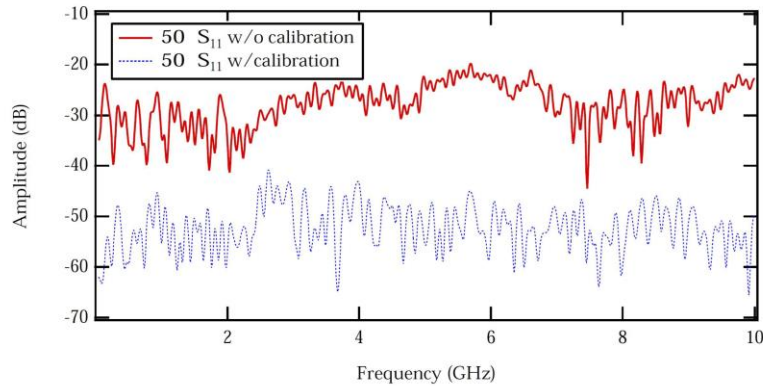
Fun with the VNA!



- The “look and feel” between VNAs vary between manufacturers and models
 - Concepts and operation is still very similar

- Calibration is not necessary for pure frequency or phase measurements
- Before calibrating the VNA measurement setup, perform a brief measurement and chose appropriate VNA settings:
 - Frequency range (center, span or start, stop)
 - Number of frequency points
 - Can be sometimes increased by rearranging the VNA memory (# of channels)
 - IF filter bandwidth
 - Output power level
- **Calibrate the setup, preferable with an electronic calibration system if more than 2 ports are used!**
 - Each port and combination needs to be calibrated, with the cables attached
 - Choose the appropriate connector type and sex
 - The instrument establishes a correction matrix and displays the "CAL" status.

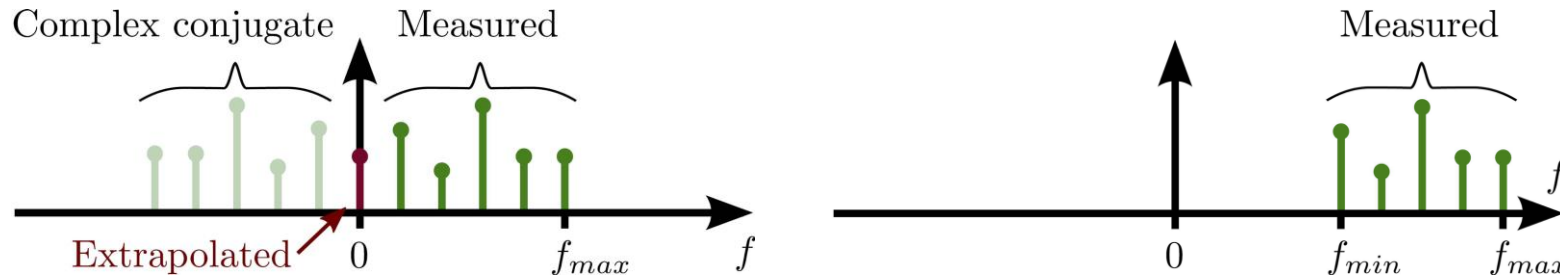




- **Calibration improves the measurement performance**
 - Return loss improvement by typically 20 dB. Enables m dB accuracy measurements!
 - Full 2-port or 4-port calibration with manual calibration kits is prone to errors, better use electronic calibration systems.
 - Change VNA settings will cause the instrument to inter- and extrapolate, and the calibration status becomes uncertain.
- **Cables are included in the calibration**
 - However, changing coaxial connector types not.
 - Special VNA cables allows the adaption of different connector types and sex, without requiring a re-calibration of the setup!

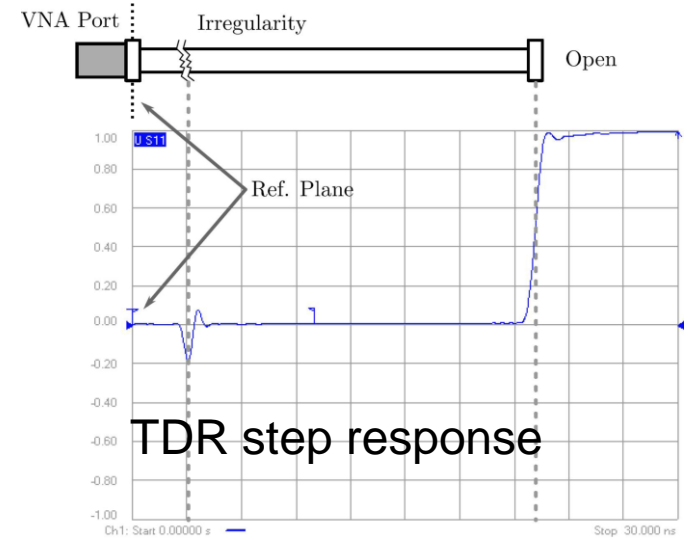
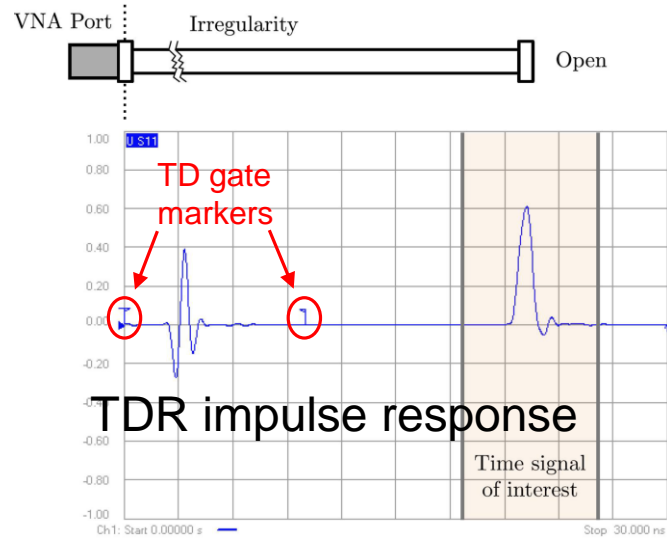
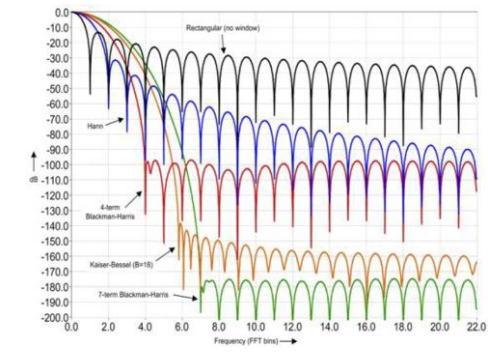
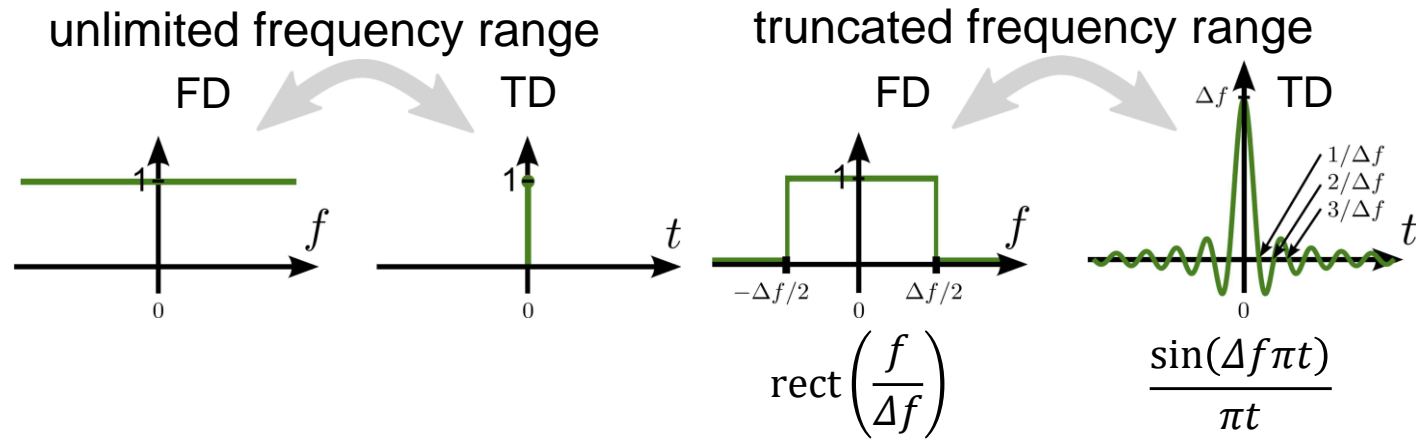
- **Modern VNAs (SAs, oscilloscopes, etc. as well) have many “features”**
- **Hardware features, e.g.**
 - Automatic calibration system, down to DC
 - 4 and more ports
 - Additional 2nd source, for downconverter / mixer measurements
 - Integrated spectrum analyzer function
- **Software, control and data post processing options, e.g.**
 - Far too many to list all
 - Sweep options, e.g., lin., log., segmented, in frequency or power
 - iDFT (or iFFT), gating
 - TDR, TDT for BP or LP step or impulse, segmented (advanced) TDR
 - Only for linear, time-invariant systems!
 - Port extension, virtual ports (4-port VNA), Z_{0e} , Z_{0o} characterization, virtual baluns, etc.
 - Data transformations, e.g., $\Gamma \Rightarrow Z$
 - Noise figure measurements
 - Measurements following telecommunication standards

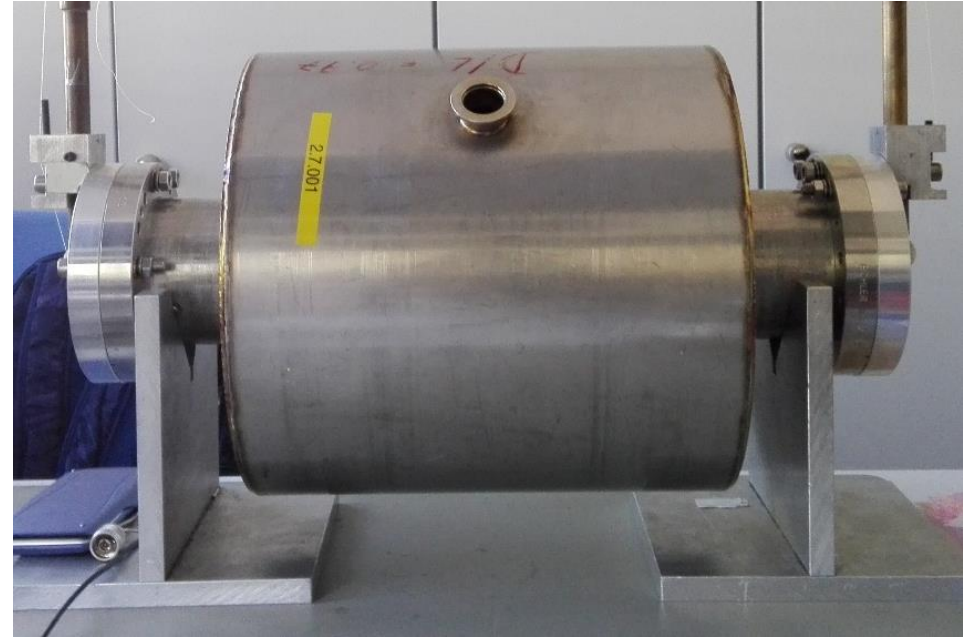
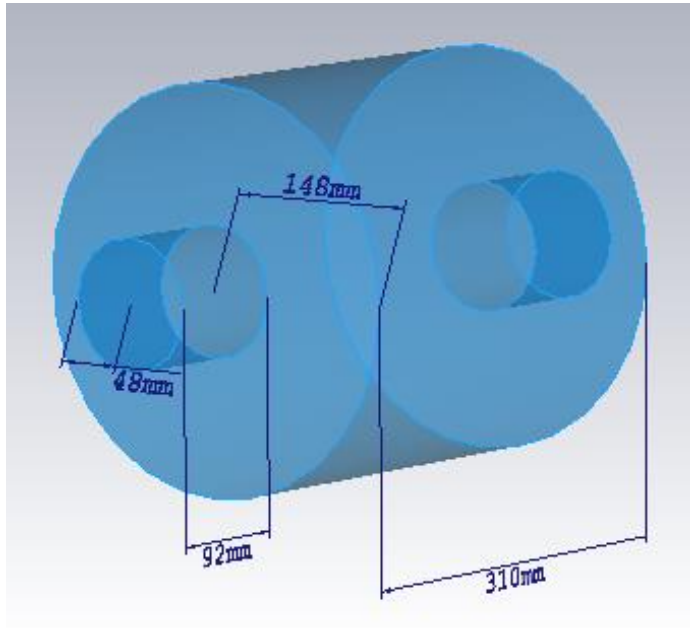
- Based on an inverse discrete *Fourier* transformation (iDFT) option in the VNA



- **Low-pass mode: Impulse or step response, relying on equidistant samples over the extrapolated (to DC) frequency range.**
 - **The VNA does not measure at DC!**
 - Manually match frequency range and # of points for DC extrapolation, e.g., 1...1000 MHz -> 1001 points, to enable extrapolation exactly to DC, or let the instrument chose the extrapolation settings automatically
- **Enables time-domain reflectometry (TDR)**
 - Very useful on portable VNAs, troubleshooting RF cable problems
- **Band-pass response (no DC extrapolation)**
- **Allows time-domain gating and de-embedding of non-resonant sub-systems, e.g., measurements on a PCB**
- **Limited to linear systems**
- **Select the "real" format for S_{11} or S_{21} for time-domain transformations (*Keysight* instruments)!**
 - or dB magnitude to detect small reflections in TDR analysis

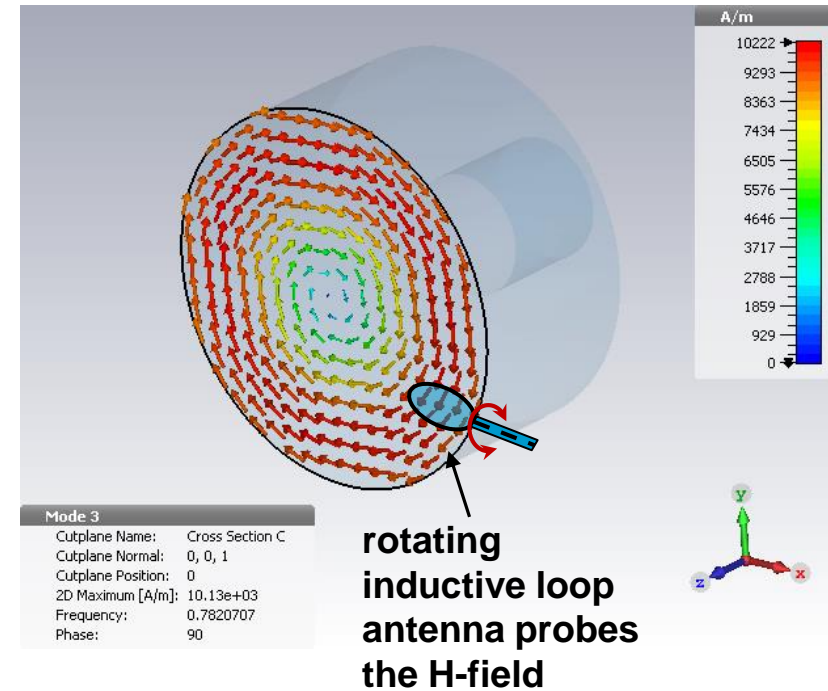
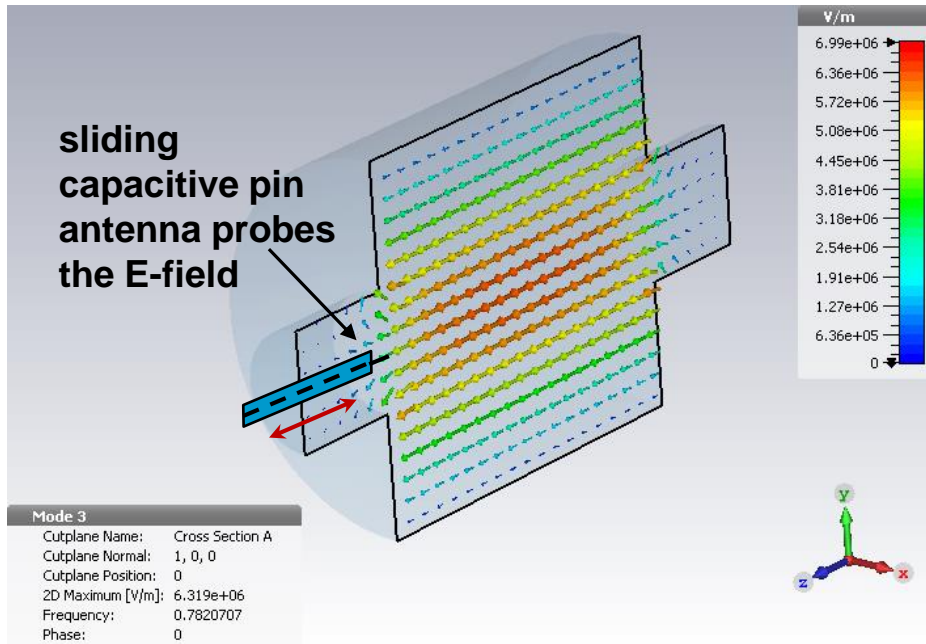
Synthetic Pulse TD Measurements (2)





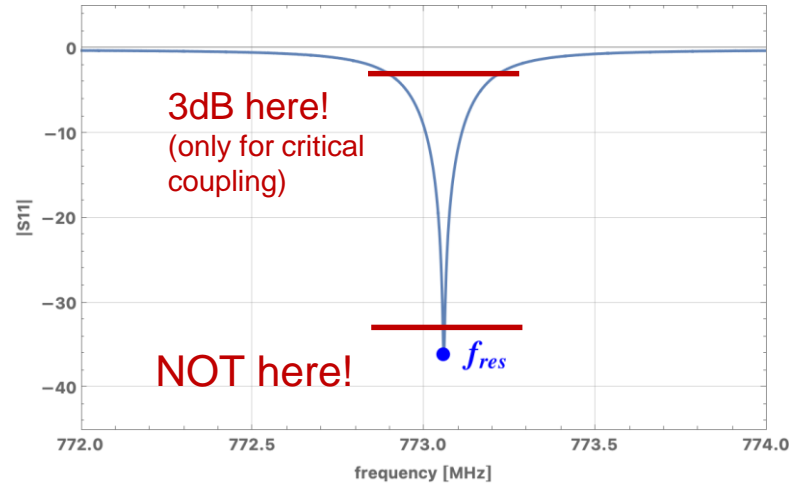
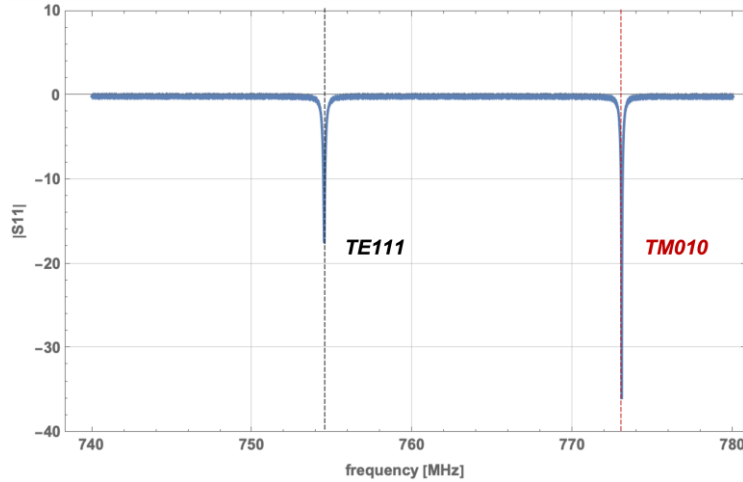
- Characterize the accelerating TM_{010} mode of a cylindrical cavity with beam ports
 - The TM_{010} does not have to be the lowest frequency mode
- Compare the measured values of f_{res} , Q_0 and R/Q
 - with an analytical analysis of a perfect cylinder (no beam ports)
 - with a numerical analysis

* normal conducting!

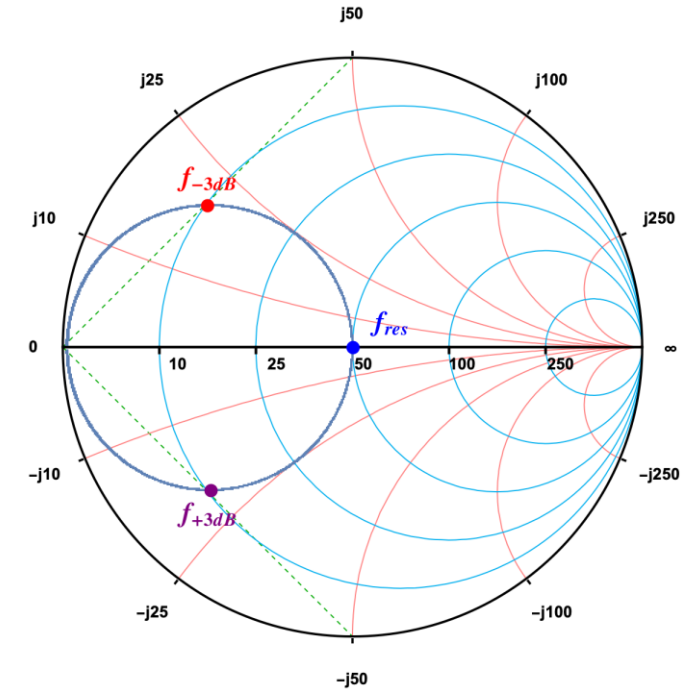


- S_{11} measurement with tunable coupling antenna
 - E-field on z-axis using a capacitive coupling pin
 - Center pin, e.g., of semi-rigid coaxial cable
 - H-field on the cavity rim using an inductive coupling loop
 - Bend the center conductor to a closed loop connected to ground

Measurement of Frequency and Q-value

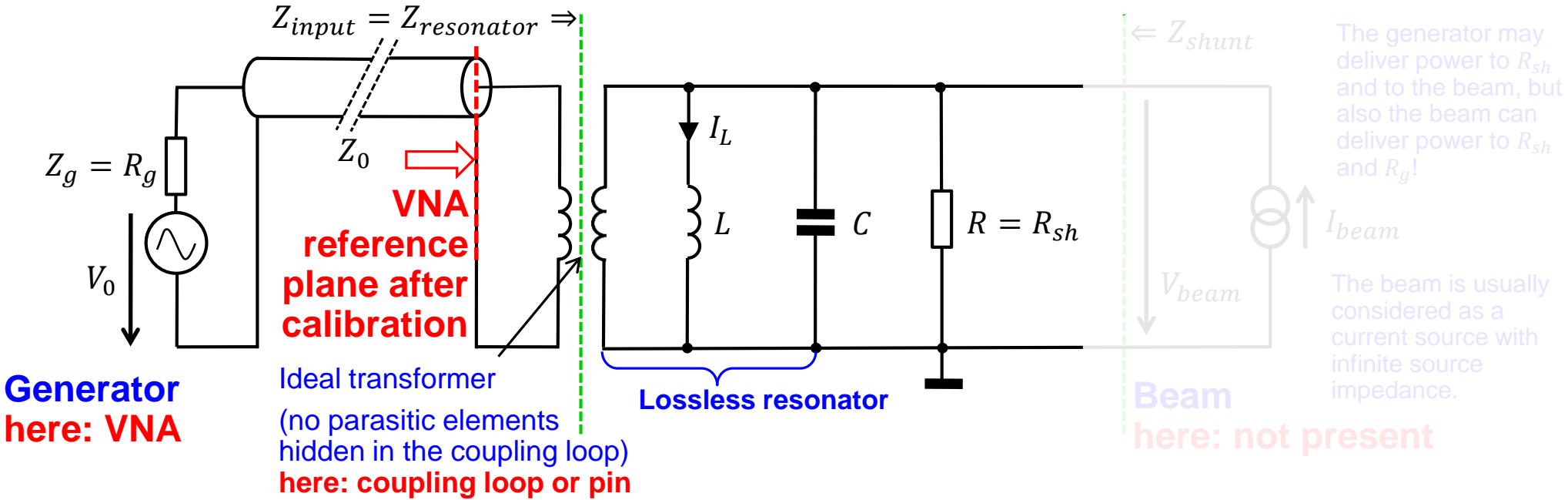


classical mistake!



- **Identify the correct (TM_{010}) mode frequency**
 - Introduce a small perturbation, e.g., metallic rod or wire on the z-axis, and observe the shift of the mode frequencies
- **Calibrate the VNA and measure S_{11}**
 - Tune the coupling loop for critical coupling
 - Display the resonant circle in the *Smith* chart using enough points!

The Equivalent Circuit of a Resonant Mode



$R = R_{sh}$: shunt resistor, representing the losses of the resonator

We have resonance condition, when $\omega L = \frac{1}{\omega C}$

→ Resonance frequency: $\omega_{res} = 2\pi f_{res} = \frac{1}{LC} \Rightarrow f_{res} = \frac{1}{2\pi\sqrt{LC}}$

- Characteristic impedance "R over Q"
- Stored energy at resonance
- Dissipated power
- Q-factor
- Shunt impedance (circuit definition)
- Tuning sensitivity
- Coupling parameter (shunt impedance over generator or feeder impedance)

$$X = \frac{R}{Q} = \omega_{res} L = \frac{1}{\omega_{res} C} = \sqrt{L/C}$$

$$U = U_e + U_m = \frac{1}{4} |V_C|^2 C + \frac{1}{4} |I_L|^2 L$$

V_C ... Voltage at the capacitor
 I_L ... Current in the inductor

$$P = \frac{V^2}{2R}$$

$$Q = \frac{R}{X} = \frac{\omega_{res} U}{P}$$

U ... stored energy
 P ... dissipated power over 1 period

$$R = \frac{V^2}{2P} \quad \frac{R}{Q} = \frac{V^2}{2\omega_{res} U}$$

$$\frac{\Delta f}{f} = \frac{1}{2} \frac{\Delta C}{C} = -\frac{1}{2} \frac{\Delta L}{L}$$

$$k^2 = \frac{R}{R_{input}}$$

tune for critical coupling

- The quality (Q) factor of a resonant circuit is defined as ratio of the stored energy U over the energy dissipated P in one oscillation cycle:

$$Q = 2\pi \frac{\text{energy stored}}{\text{energy dissipated in 1 cycle}} = \frac{\omega_{res}U}{P}$$

- The Q -factor of an impedance loaded resonator:

- Q_0 : unloaded Q-value of the unperturbed system
- Q_L : loaded Q-value, e.g., measured with the impedance of the connected generator
- Q_{ext} : external Q-factor, representing the effects of the external circuit (generator and coupling circuit)

- Q-factor and bandwidth**

- This is how we actually "measure" the Q-factor!

$$Q = \frac{f_{res}}{f_{BW}}$$

with: $f_{BW} = f_{+3dB} - f_{-3dB}$

$$\frac{1}{Q_L} = \frac{1}{Q_0} + \frac{1}{Q_{ext}}$$

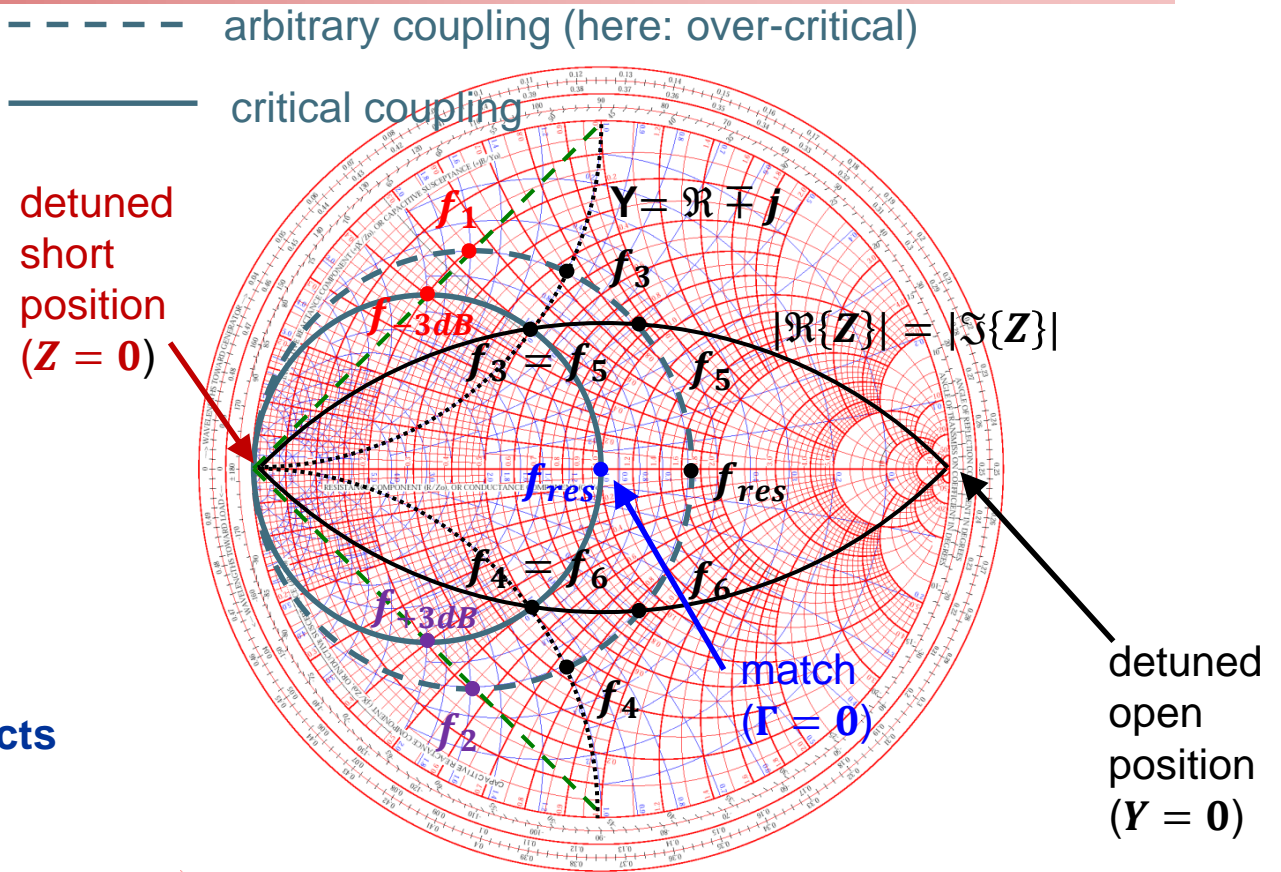
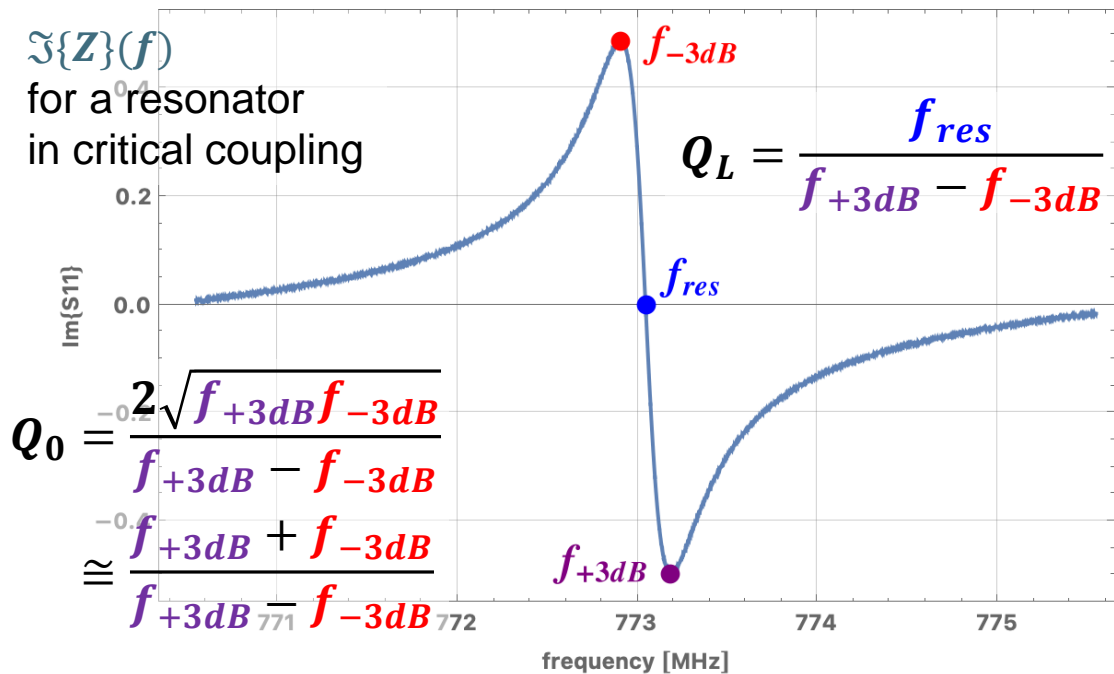
tune k for critical coupling:

$$Q_0 = Q_{ext}$$

$$\Rightarrow Q_0 = 2 Q_L$$

With Q_L being our measured Q-value

Q-factor from S_{11} Measurement



- **Correct for the uncompensated transmission-line effects between calibration reference and the coupling loop**
 - Electrical length adjustment: "straight" $\Im\{Z\}(f)$
- **Adjust the locus circle to the detuned short location**
 - Phase offset
- **Verify no evanescent fields penetrating outside the beam ports**
 - i.e., no frequency shifts if the boundaries at the beam ports are altered

Frequency marker points in the *Smith* chart:
 $f_{1,2}$ (f_{-3dB}, f_{+3dB}): $|\Im\{S_{11}\}| = \mathbf{max}$. to calculate Q_L
 $f_{3,4}$: $Y = \Re + j$ to calculate Q_{ext}
 $f_{5,6}$: $|\Re\{Z\}| = |\Im\{Z\}|$ to calculate Q_0

- Remember from the equivalent circuit:

$$\frac{R}{Q} = \frac{V_{acc}^2 / 2P_d}{\omega_{res} U / P_d} = \frac{V_{acc}^2}{2\omega_{res} U} \quad \text{with:} \quad V_{acc} = \left| \int E_z(z) \cos\left(\frac{\omega z}{\beta c_0}\right) dz \right|$$

transit time related

- V_{acc} is based on the integrated longitudinal E-field component E_z along the z-axis ($x = y = 0$)

- Based on Slater's perturbation theorem:

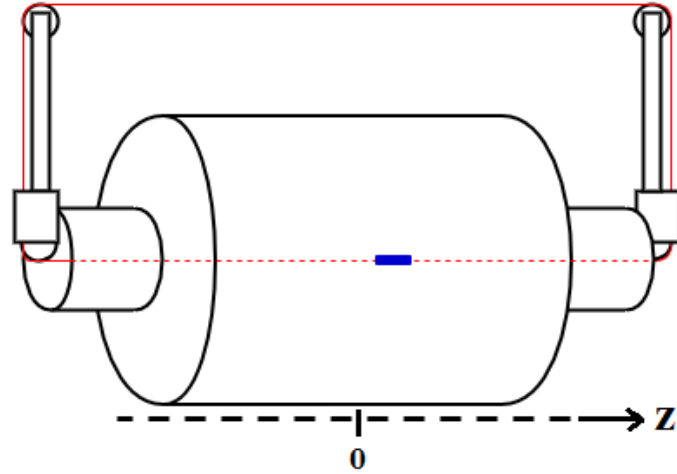
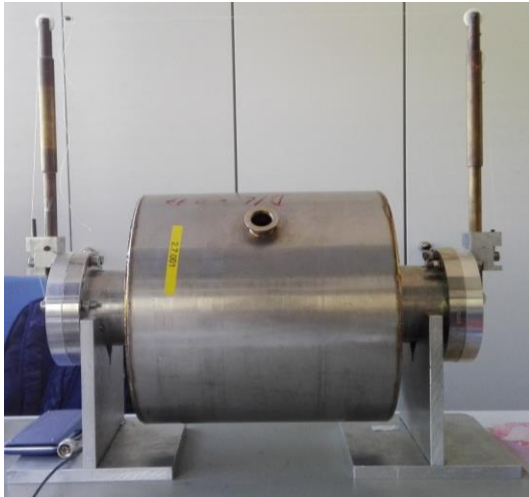
$$\frac{\Delta f}{f_{res}} = \frac{1}{U} \left[\mu_0 \left(k_{\parallel}^H |H_{\parallel}|^2 + k_{\perp}^H |H_{\perp}|^2 \right) - \epsilon_0 \left(k_{\parallel}^E |E_{\parallel}|^2 + k_{\perp}^E |E_{\perp}|^2 \right) \right]$$

- Resonance frequency shift due to a small perturbation object, expressed in longitudinal and transverse E and H field components
- k : coefficients proportional to the electric or magnetic polarizability of the perturbation object (here: only k_{\parallel}^E for a longitudinal metallic object)

- E-field characterization along the z-axis

$$E(z) = E_{\parallel}(z) = \sqrt{U \frac{\Delta f(z)}{f_{res}} \cdot \frac{-1}{k_{\parallel}^E \epsilon_0}}$$

with: $k_{\parallel}^E = \frac{\pi}{3} l^3 \left[\sinh^{-1} \left(\frac{2l}{3\pi a} \right) \right]^{-1}$
 (metallic ellipsoid, e.g., syringe needle of half length l and radius a)



- **E-field characterization by evaluating**

- The frequency shift Δf (S_{11} reflection measurement with a single probe) or
- The phase shift ϕ at f_{res} (S_{21} transmission measurement with 2 probes)

$$\frac{\Delta f}{f_{res}} = \frac{1}{2 Q_0} \tan \phi$$

- **Exercise with a manual bead-pull through a known cavity**

- requires: fishing wire, syringe needle, ruler and VNA
- Compare the measured E_z at the maximum f or ϕ shift (in the center of the cavity) with the theoretical estimation (e.g., numerical computed value)

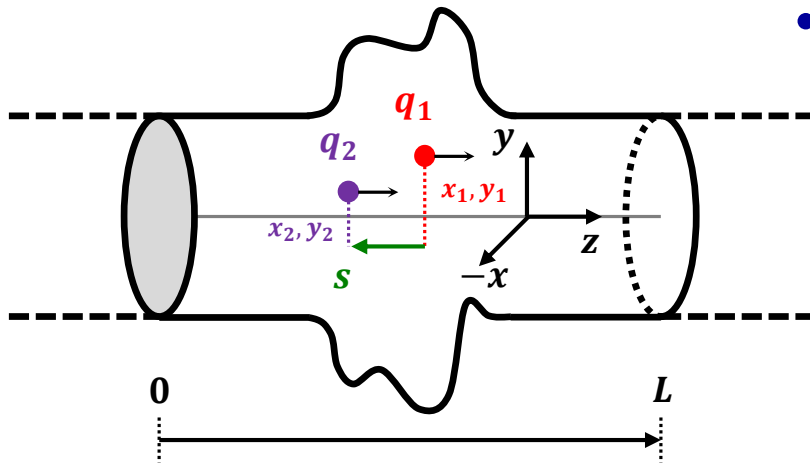
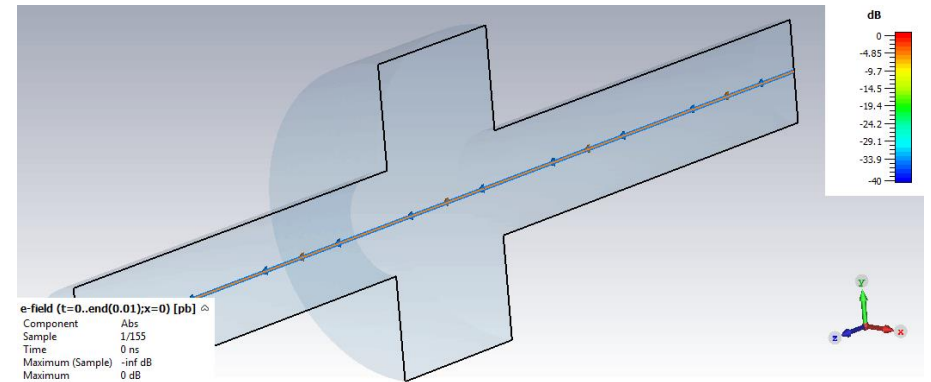
- **The wake potential**

- Lorenz force on q_2 by the wake field of q_1 :

$$\vec{F} = \frac{d\vec{p}}{dt} = q_2(\vec{E} + c_0\vec{e}_z \times \vec{B})$$

- Wake potential of a structure, e.g., a discontinuity driven by q_1

$$\vec{w}(x_1, y_1, x_2, y_2, s) = \frac{1}{q_1} \int_{-\infty \text{ (or } 0)}^{+\infty \text{ (or } L)} dz [\vec{E}(x_2, y_2, z, t) + c_0\vec{e}_z \times \vec{B}(x_2, y_2, z, t)]_{t=(s+z)/c}$$



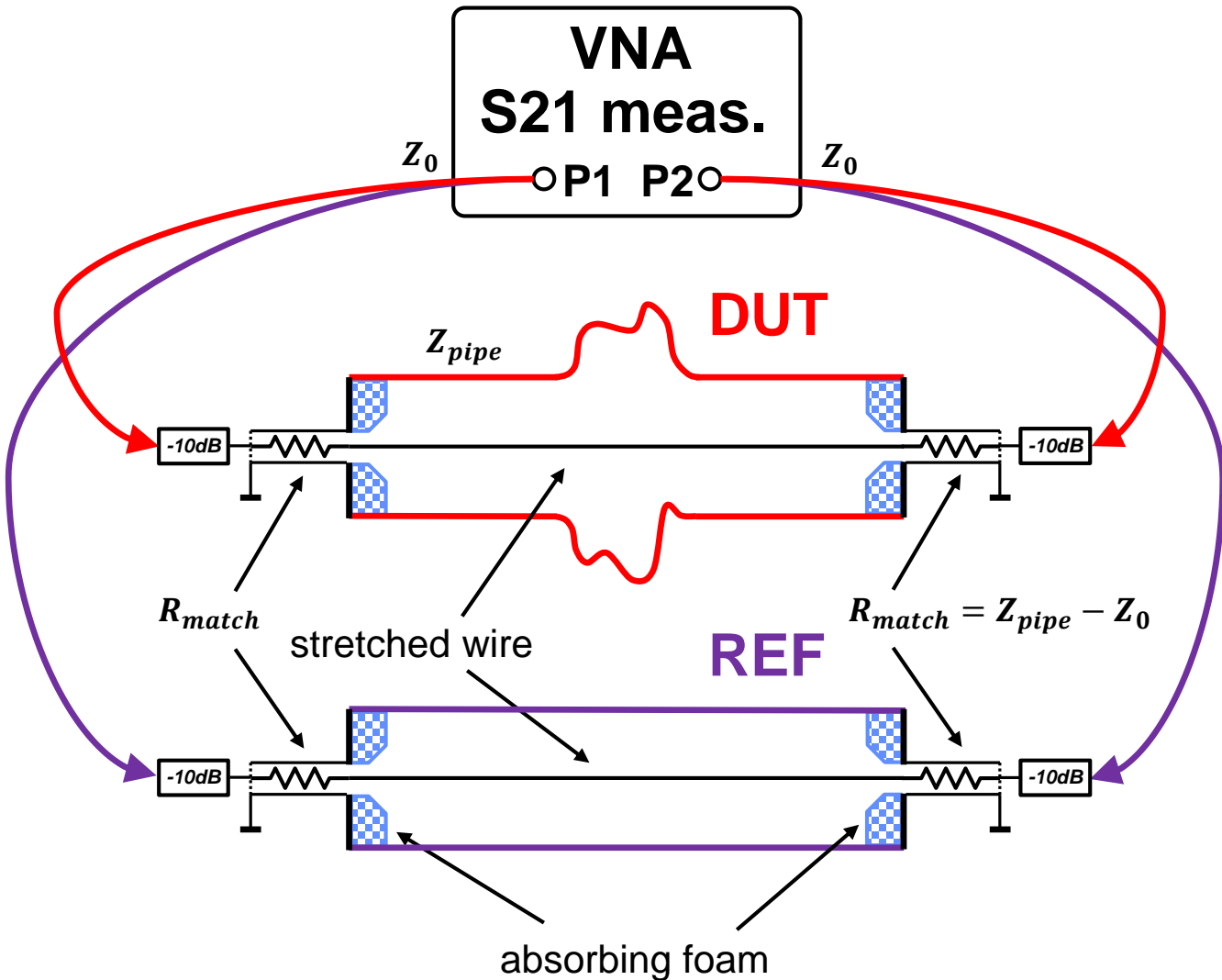
- **Beam coupling impedance**

- Frequency domain representation of the wake potential

$$Z(x_1, y_1, x_2, y_2, \omega) = -\frac{1}{c_0} \int_{-\infty}^{+\infty} ds \vec{w}(x_1, y_1, x_2, y_2, s) e^{-j\omega s/c_0}$$

- Can be decomposed in **longitudinal Z_{\parallel}** and **transverse Z_{\perp}** components (*Panofsky-Wenzel* theorem)

- Resonant structures, i^{th} mode: $R_{sh,i} = Z_{\parallel,i} = \frac{2k_{loss,i}Q_i}{\omega_i}$



- **Formulas:**

- Normalized electrical length: $\theta = 2\pi \frac{L}{\lambda}$

- Lumped impedance formula

$$Z_{\parallel} = 2Z_{pipe} \frac{1 - S_{21}}{S_{21}} \quad \begin{matrix} \theta \leq 1 \\ L < D_{pipe} \end{matrix}$$

- Log formula

$$Z_{\parallel} = -2Z_{pipe} \ln S_{21}$$

- Improved log formula

$$Z_{\parallel} = -2Z_{pipe} \ln S_{21} \left(1 + j \frac{\ln S_{21}}{2\theta} \right)$$

- Transmission coefficient

$$S_{21} = \frac{S_{21,DUT}}{S_{21,REF}}$$

- Circular beam pipe impedance

$$Z_{pipe} = \frac{\eta_0}{2\pi\sqrt{\epsilon_r}} \ln \frac{D}{d} \cong 60 \Omega \ln \frac{D_{pipe}}{d_{wire}}$$

- **No summary, just thank you for listening!**
- **Also, a big THANK YOU to all the help from the hands-on instructors!**
- **More THANKS to *Dassault / CST, SIMUSERV (Frank)* and *Computer Controls / Keysight***
- **THANK YOU to my colleagues at CERN, in particular *Joel D.!***

Thank you!



Backup Slides



- **Characteristic impedance**

- for a TEM transmission-line

- with losses

$$Z_0 = \sqrt{\frac{R' + j\omega L'}{G' + j\omega C'}} \quad [\Omega]$$

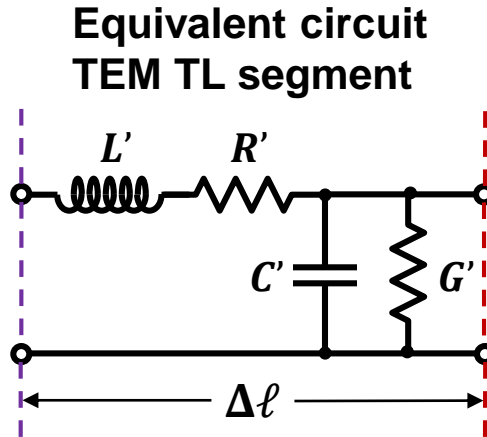
- lossless, non-magnetic media ($\mu_r = 1$)

$$Z_0 \cong \sqrt{\frac{L'}{C'}} \quad [\Omega]$$

$$Z_0 \cong \frac{\sqrt{\mu_0 \epsilon_0 \epsilon_r}}{c C'} = \frac{\sqrt{\epsilon_r}}{c C'} = \frac{1}{v_p C'} \quad [\Omega]$$

The characteristic impedance can be calculated from 2D electrostatic equations

$$Z_0 \cong \frac{c L'}{\sqrt{\mu_0 \epsilon_0 \epsilon_r}} = \frac{c L'}{\sqrt{\epsilon_r}} = v_p L' \quad [\Omega]$$



- **Propagation constant**

- for a TEM transmission-line

$$\gamma = \sqrt{(R' + j\omega L')(G' + j\omega C')}$$

$$\gamma = \alpha + j\beta = \sqrt{j\omega\mu(\sigma + j\omega\epsilon)}$$

- attenuation constant

$$\alpha = \omega \sqrt{\frac{\mu\epsilon}{2} \left(\sqrt{1 + \frac{\sigma^2}{\omega^2\epsilon^2}} - 1 \right)} \quad \left[\frac{Np}{m} \right]$$

- phase constant

$$\beta = \omega \sqrt{\frac{\mu\epsilon}{2} \left(\sqrt{1 + \frac{\sigma^2}{\omega^2\epsilon^2}} + 1 \right)} \quad \left[\frac{rad}{m} \right]$$

$$\beta = \frac{2\pi}{\lambda_g} \quad \left[\frac{rad}{m} \right]$$

$$\beta = \omega\sqrt{L'C'}$$

- Wave impedance**

in media

$$\eta = \sqrt{\frac{\mu}{\epsilon}} \quad [\Omega]$$

Characteristic impedance of free space

$$\eta_0 = \sqrt{\frac{\mu_0}{\epsilon_0}} \cong 120\pi \quad [\Omega] \cong 377 \quad [\Omega]$$

- Speed of light**

$$c = \frac{1}{\sqrt{\mu_0 \epsilon_0}} \cong 2.997925 \cdot 10^8 \quad \left[\frac{m}{s}\right]$$

- Phase velocity**

$$v_p = \frac{1}{\sqrt{L'C'}} = \frac{1}{\sqrt{\mu\epsilon}} = \frac{1}{\sqrt{\mu_0\mu_r\epsilon_0\epsilon_r}} = \frac{c}{\sqrt{\mu_r\epsilon_r}} \quad \left[\frac{m}{s}\right]$$

– non-magnetic media ($\mu_r = 1$)

$$v_p \cong \frac{c}{\sqrt{\epsilon_r}} \quad \left[\frac{m}{s}\right]$$

- Wavelength**

in free space

$$\lambda_0 = \lambda = \frac{c}{f} \quad [m]$$

guide wavelength (in media)

$$\lambda_g = \frac{c}{f\sqrt{\mu_r\epsilon_r}} = \frac{\lambda_0}{\sqrt{\mu_r\epsilon_r}} \quad [m]$$

– non-magnetic media:
($\mu_r = 1$)

$$\lambda_g \cong \frac{c}{f\sqrt{\epsilon_r}} \quad [m]$$

- Electrical length**

– for a TEM line of physical length ℓ

$$\theta = \beta\ell = 2\pi \frac{\ell}{\lambda_g} \quad [rad]$$

$$\theta = \beta\ell = 360 \frac{\ell}{\lambda_g} \quad [deg]$$

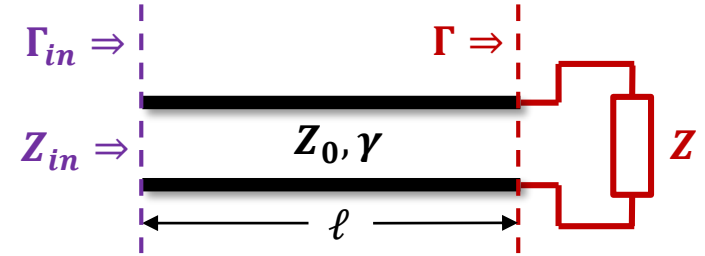
- Permeability:** $\mu = \mu_0\mu_r$ $\mu_0 \cong 4\pi \cdot 10^{-7} \quad [H/m]$

- Permittivity:** $\epsilon = \epsilon_0\epsilon_r$ $\epsilon_0 \cong 8.854 \cdot 10^{-12} \quad [F/m]$

- **Transmission-line terminated with an arbitrary impedance Z :**

$$Z_{in} = Z_0 \frac{1 + \Gamma_{in}}{1 - \Gamma_{in}} \quad \text{with: } \Gamma_{in} = \Gamma e^{-2\gamma\ell} \quad \text{and: } \Gamma = \frac{Z - Z_0}{Z + Z_0}$$

$$Z_{in} = Z_0 \left(\frac{Z \cosh \gamma\ell + Z_0 \sinh \gamma\ell}{Z_0 \cosh \gamma\ell + Z \sinh \gamma\ell} \right) = Z_0 \frac{Z + Z_0 \tanh \gamma\ell}{Z_0 + Z \tanh \gamma\ell} \quad [\Omega]$$



- **Lossless transmission-line:**

$$\alpha = 0 \Rightarrow$$

$$Z_{in} = Z_0 \left(\frac{Z \cos \beta\ell + jZ_0 \sin \beta\ell}{Z_0 \cos \beta\ell + jZ \sin \beta\ell} \right) \quad [\Omega]$$

– Popular applications

➤ Quarter-wave line: $\ell = \frac{\lambda}{4} \Rightarrow \theta = \frac{\pi}{2} \Rightarrow Z_{in} = \frac{Z_0^2}{Z}$

➤ Terminated (matched) line: $Z = Z_0 \Rightarrow Z_{in} = Z_0$

➤ Open line: $Z \rightarrow \infty \Rightarrow Z_{in} = -jZ_0 \cot \beta\ell$

➤ Shorted line: $Z = 0 \Rightarrow Z_{in} = jZ_0 \tan \beta\ell$

$$Z_{in,open} = -j Z_0 \cot \beta \ell$$

$$Z_{in,short} = j Z_0 \tan \beta \ell$$

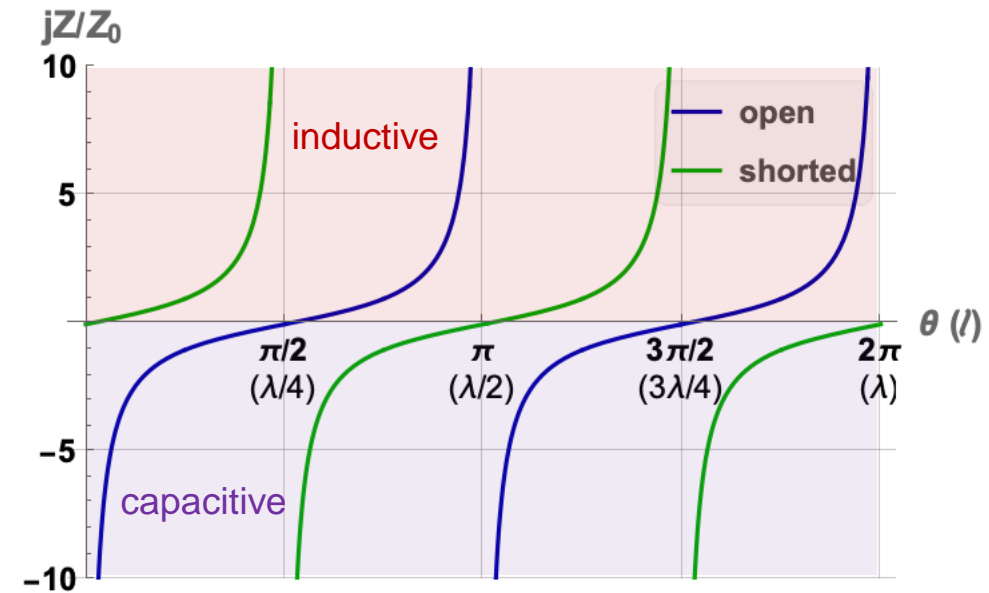
physical length ℓ electrical length $\theta = \beta \ell$	$0 < \ell < \lambda_g/4$ $0 < \theta < \pi/2$	$\lambda_g/4 < \ell < \lambda_g/2$ $\pi/2 < \theta < \pi$	$\lambda_g/2 < \ell < 3\lambda_g/4$ $\pi < \theta < 3\pi/2$	$3\lambda_g/4 < \ell < \lambda_g$ $3\pi/2 < \theta < 2\pi$
lossless TL open	“capacitive”	“inductive”	“capacitive”	“inductive”
lossless TL shorted	“inductive”	“capacitive”	“inductive”	“capacitive”

- A lossless TL with open ($Z = 0$) or shorted ($Z \rightarrow \infty$) termination can approximate a lumped reactive element (capacitor or inductor)

– A “capacitive” element has the form: $Z_C = \frac{1}{j\omega C} = -j \frac{1}{\omega C}$

– An “inductive” element has the form: $Z_L = j\omega L$

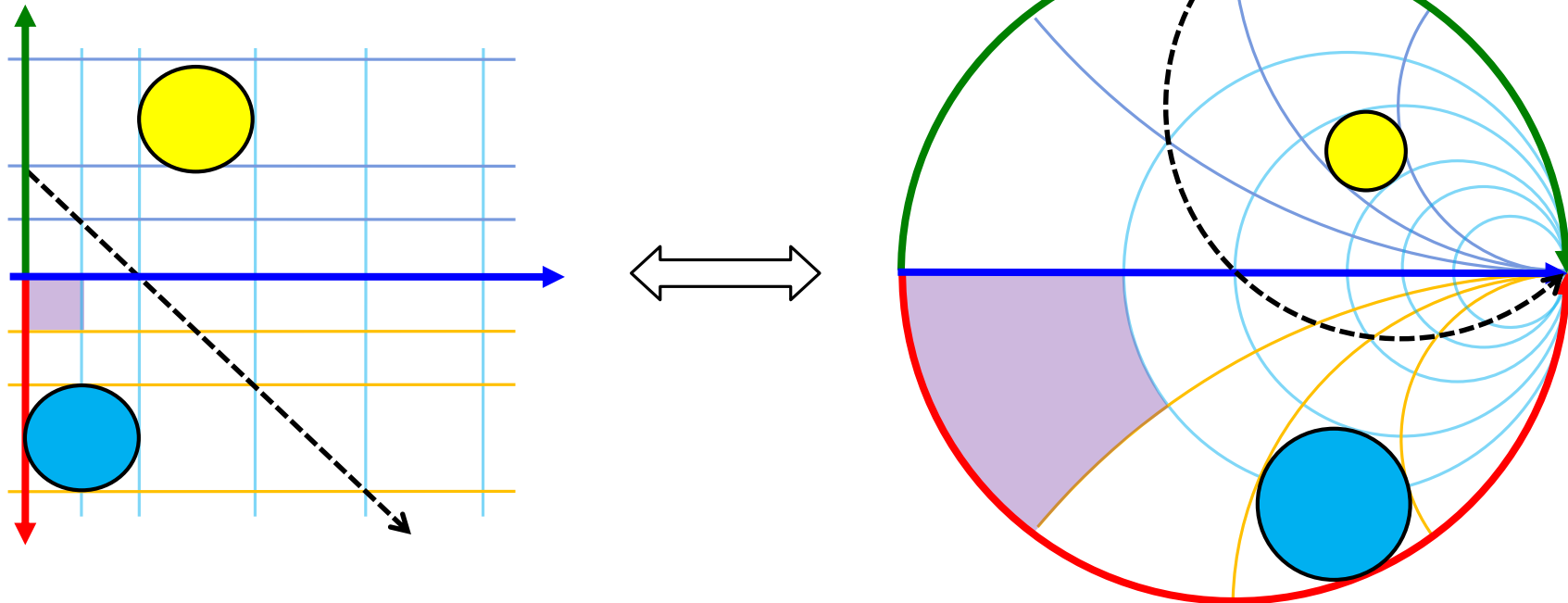
- A more precise method follows a “T” or “π” LCL or CLC equivalent circuit of the lossless TL.
- In case of $\theta \ll 1$, we can simplify $\tan \theta \cong \theta$, etc.
- In practice it is useful to select a low Z_0 for a capacitive, or a high Z_0 for an inductive semi-lumped element approximation



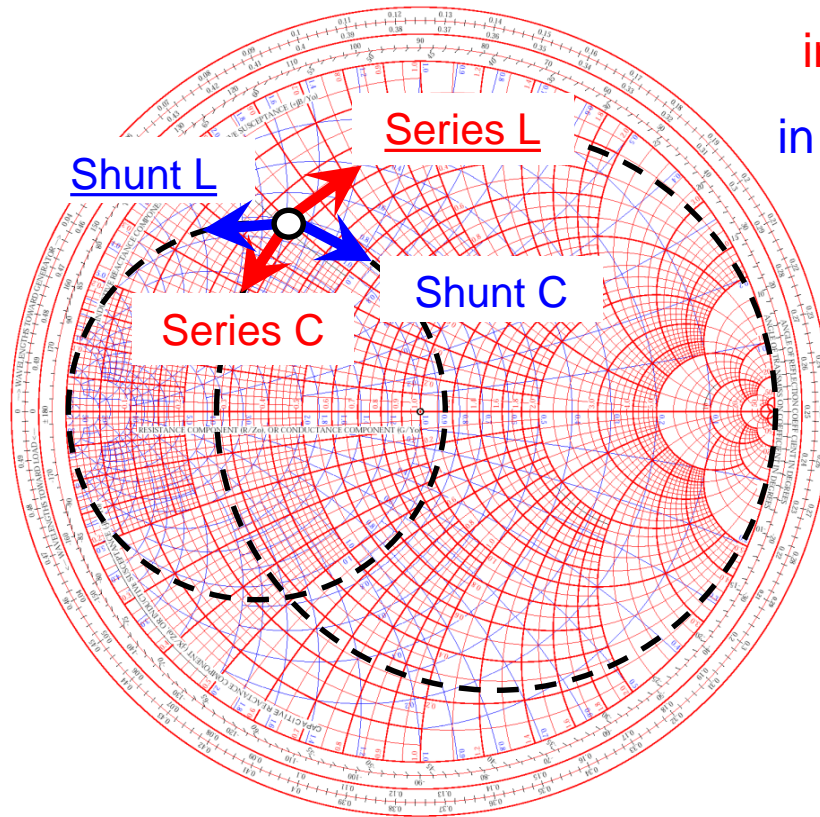
This is a “bilinear” transformation with the following properties:

- **Generalized circles are transformed into generalized circles**
 - **circle** → **circle**
 - **straight line** → **circle**
 - **circle** → **straight line**
 - **straight line** → **straight line**
- **Angles are preserved locally**

- a straight line is equivalent to a circle with infinite radius
- a circle is defined by 3 points
- a straight line is defined by 2 points



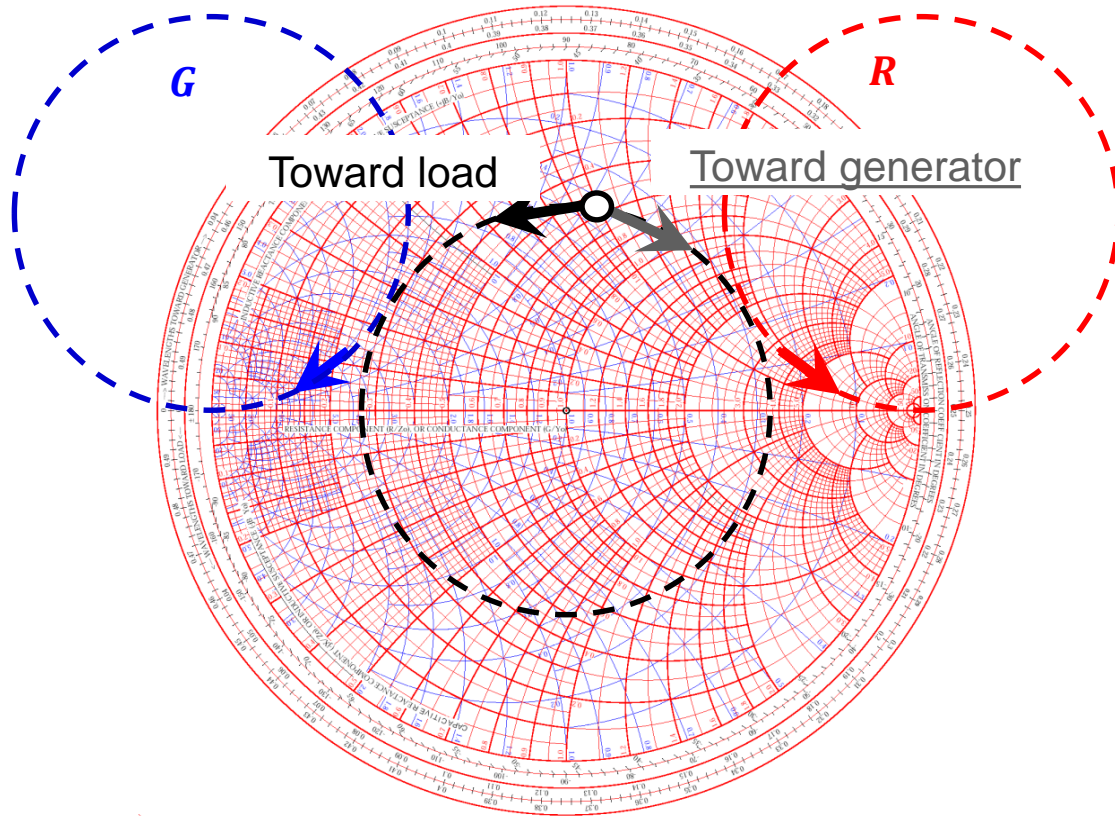
Navigation in the *Smith Chart* (2)



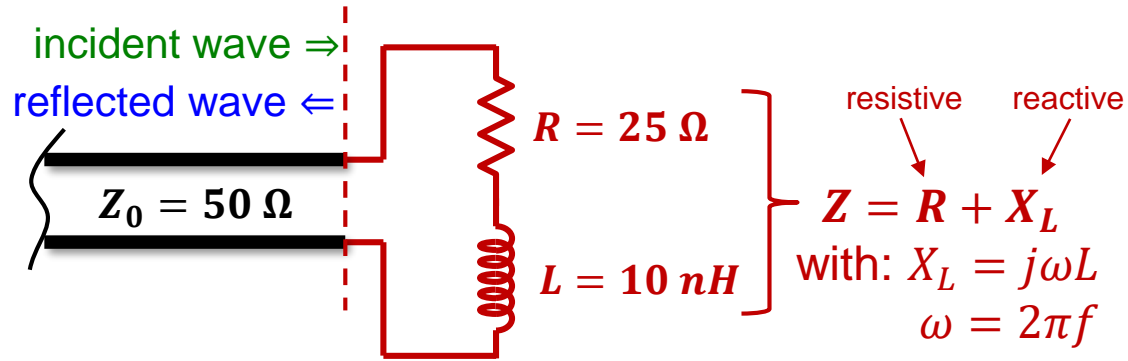
in red: impedance plane (= z)

in blue: admittance plane (= y)

	<u>Up</u>	Down
Red circles	<u>Series L</u>	Series C
Blue circles	<u>Shunt L</u>	Shunt C

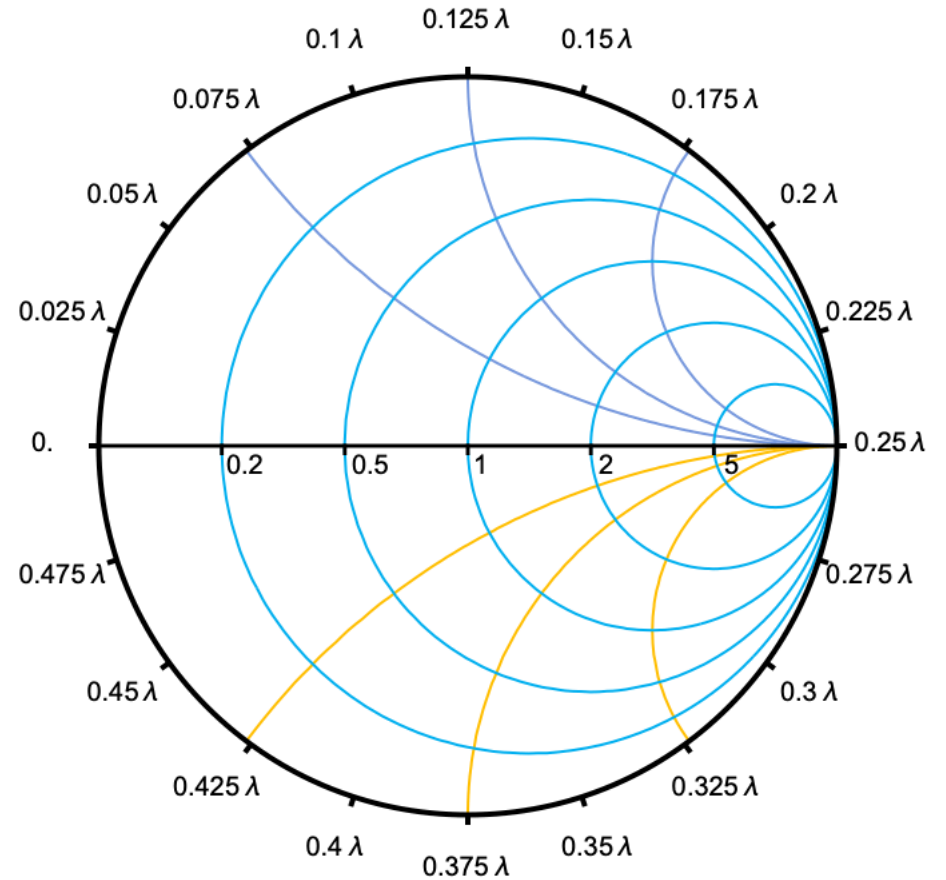


Red arcs	Resistance R
Blue arcs	Conductance G
Con-centric circle	Transmission line going Toward load <u>Toward generator</u>

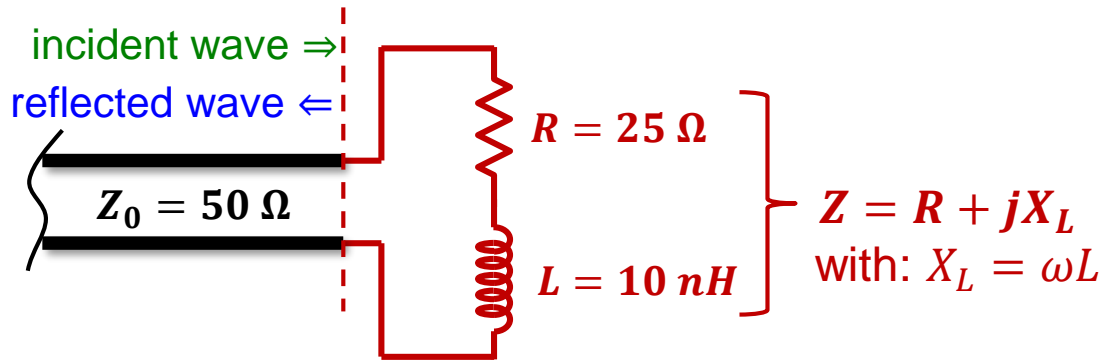


Complex impedance based on lumped element components

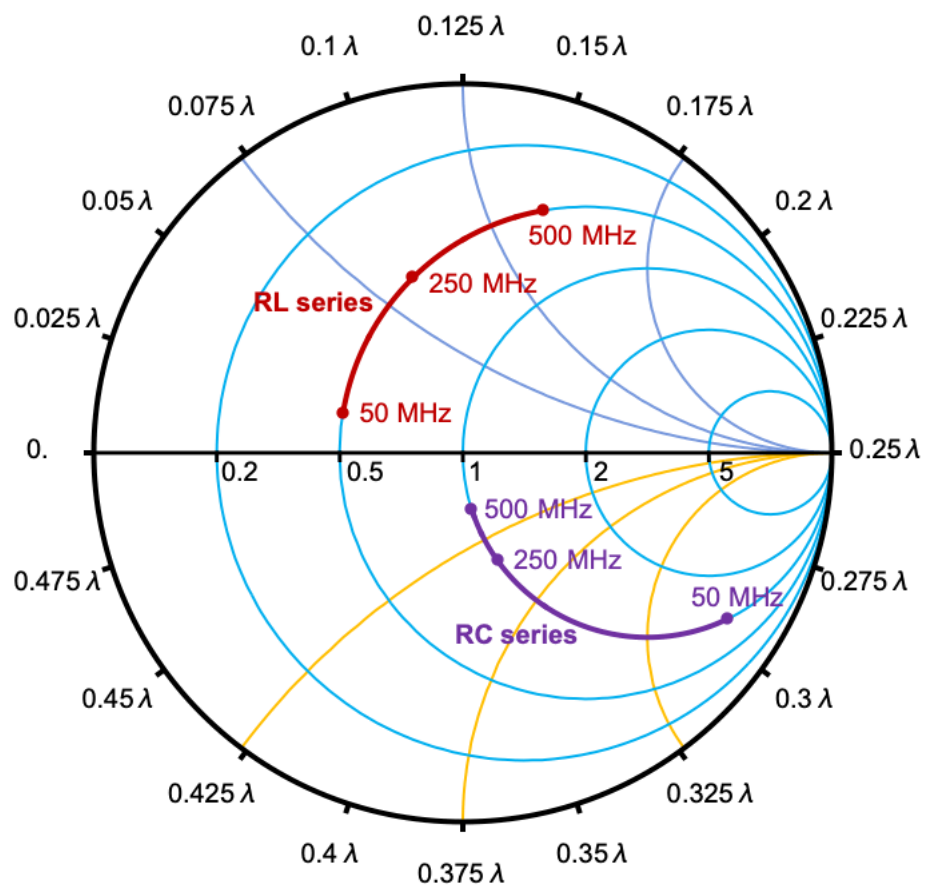
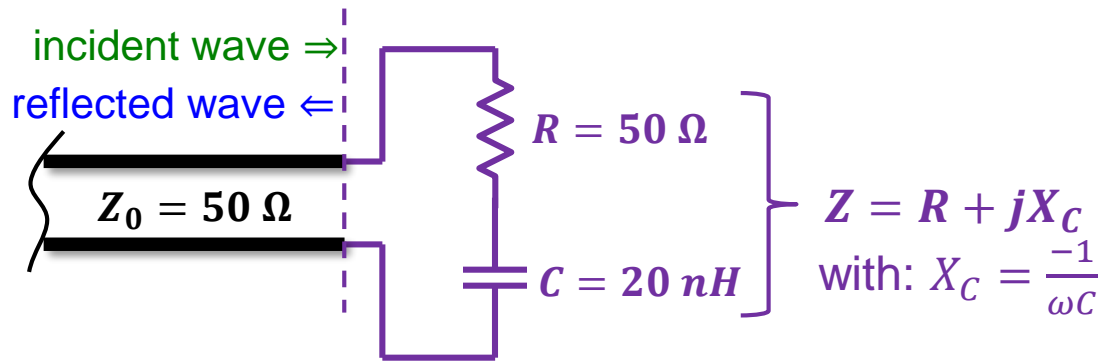
- Calculate Z for a given frequency, e.g., $f = 50 \text{ MHz}$: $Z = (25 + j6.28) \Omega$
- Calculate the normalized impedance $z = Z/Z_0 = 0.5 + j0.126$
 - Locate z in the Smith chart
 - Retrieve $\Gamma = 0.34 \angle 161^\circ = 0.34e^{j2.81}$
- Repeat for other frequencies...

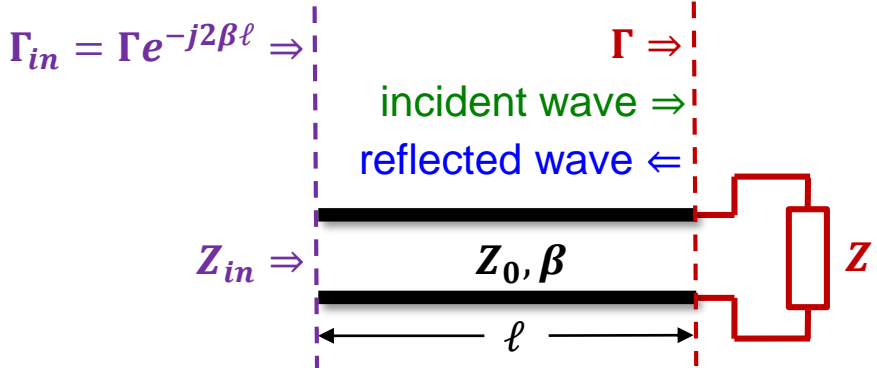


The Smith Chart – Basic Example (2)



- ...and for different component values and circuit combinations





- **S-parameter of a lossless transmission-line:**

$$S = \begin{bmatrix} 0 & e^{-j\beta\ell} \\ e^{-j\beta\ell} & 0 \end{bmatrix}$$

backward transmission coefficient S12

forward transmission coefficient S21

– Phase delay (electrical length) of

$$\theta = \beta\ell$$

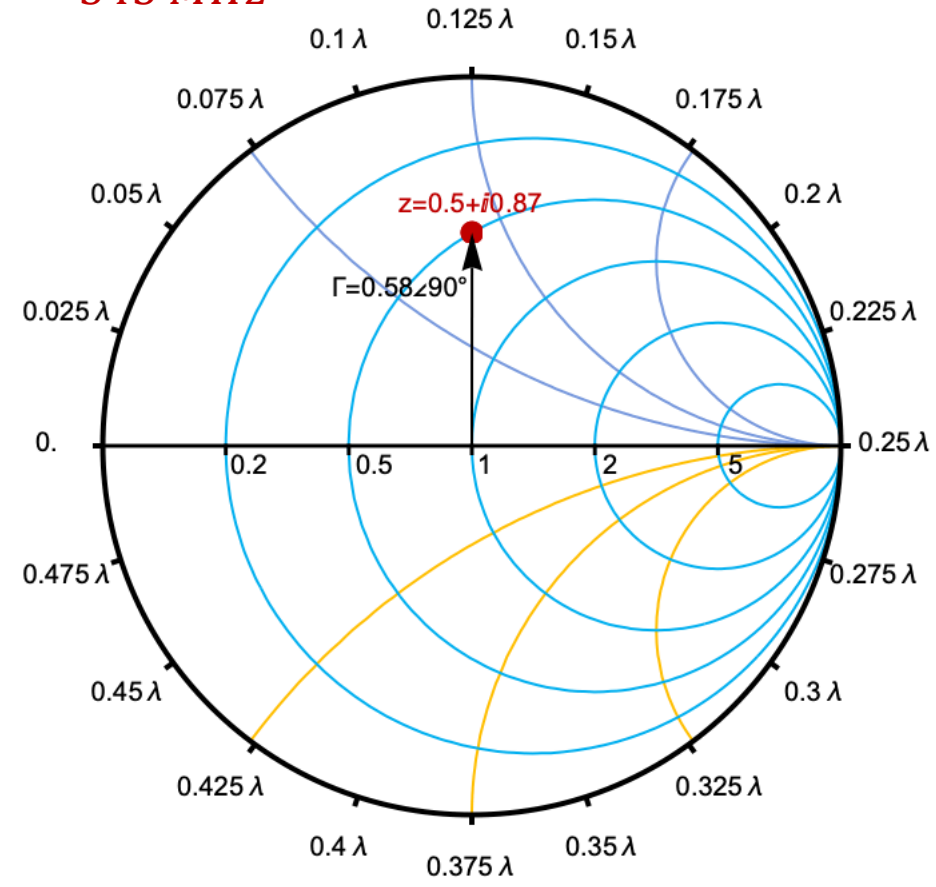
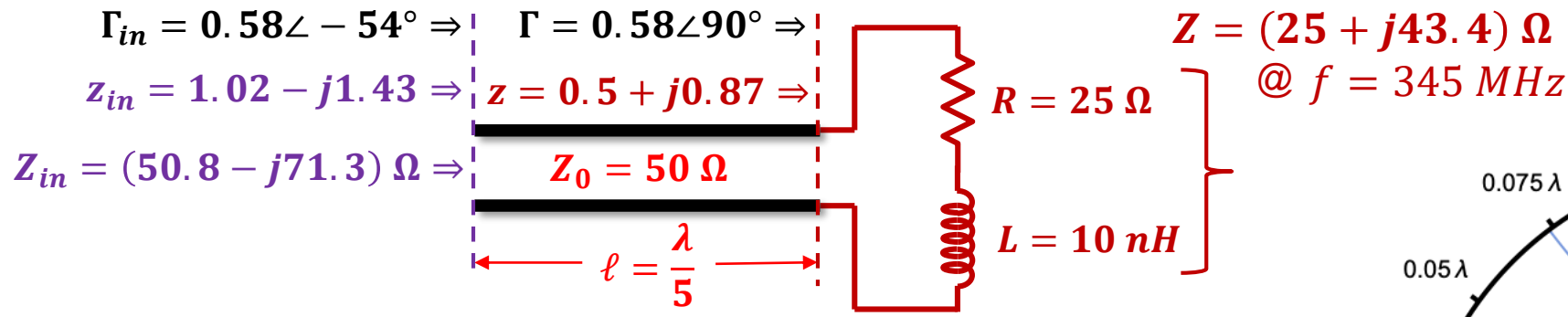
with: $\beta = \frac{2\pi}{\lambda_g}$

- The lossless transmission-line adds a phase delay of $2\beta\ell$, seen at its input, to the reflection coefficient at its output:

$$\Gamma_{in} = \Gamma e^{-j2\beta\ell}$$

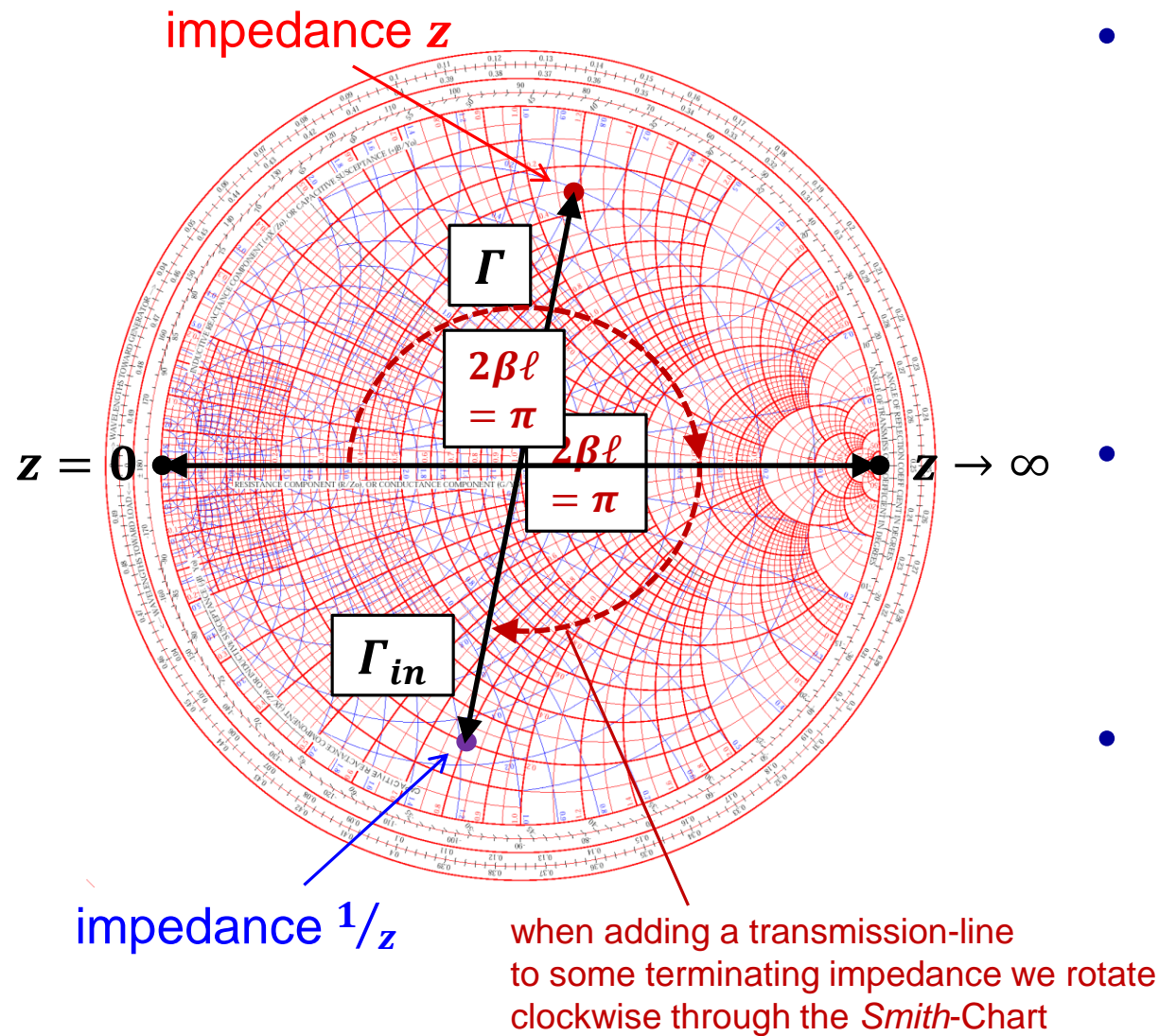
- This results in a transformation of the impedance Z at the end of the line to a different impedance Z_{in} at the input of the line

– The Smith chart offers an effective, simple graphical way to calculate this transmission-line based impedance transformation



Based on the previous example

- Calculate the normalized impedance z for $f = 345 \text{ MHz}$ and locate the point in the Smith chart.
 - Notice the corresponding value of Γ , and read the λ -length value on the rim
- Add $\ell = \lambda/5$ by rotating Γ by $2\beta\ell = 4\pi/5 \equiv 144^\circ$
 - From 0.125λ to 0.325λ
 - The phase is subtracted, therefore clockwise rotation!
- Notice the value of Γ_{in} and read the corresponding value of the normalized impedance Z_{in}
 - Calculate the transformed impedance $Z_{in}@f = 345 \text{ MHz}$
 - What is the equivalent circuit, and what are the compon
 - ...and what is the physical length ℓ of the transmission-line?
 - assuming a coaxial cable as transmission-line with a dielectric constant of $\epsilon_r = 2.1$



- A transmission-line of length

$$\ell = \lambda/4 \equiv \beta\ell = \frac{\pi}{2}$$

transforms a reflection Γ at the end of the line to its input as

$$\Gamma_{in} = \Gamma e^{-j2\beta\ell} = \Gamma e^{-j\pi} = -\Gamma$$

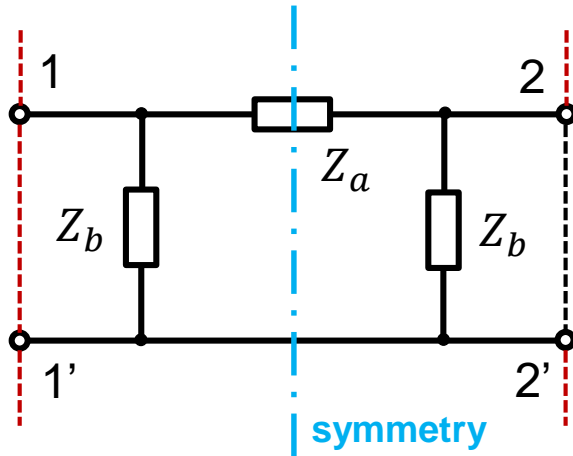
- This results the unitless, normalized impedance z at the end of the line to be transformed into:

$$z_{in} = 1/z$$

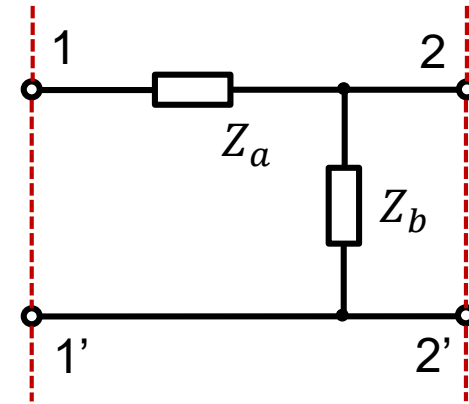
at the beginning of the line

- A short circuit at the end of the **$\lambda/4$ -transformer** is transformed to an open, and vice versa
 - This is the principle of the $\lambda/4$ -resonator.

π -network



divider-network



$$(S_{\pi}) = \frac{1}{\Delta} \begin{pmatrix} Z_a Z_b^2 - Z_0^2 (Z_a + 2Z_b) & 2Z_0 Z_b^2 \\ 2Z_0 Z_b^2 & Z_a Z_b^2 - Z_0^2 (Z_a + 2Z_b) \end{pmatrix}$$

with: $\Delta = (Z_a + Z_b)[Z_a Z_b + Z_0(Z_a + 2Z_b)]$

$S_{12} = S_{21} \wedge S_{11} = S_{22} \Rightarrow$ reciprocal and symmetric

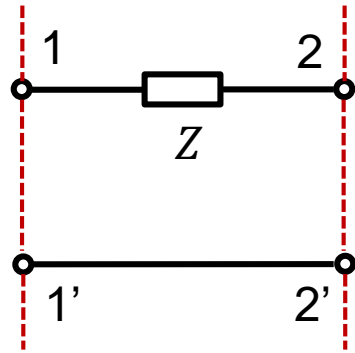
$$(S_{div}) = \frac{1}{\Delta} \begin{pmatrix} Z_a Z_b - Z_0(Z_0 - Z_a) & 2Z_0 Z_b \\ 2Z_0 Z_b & Z_a Z_b - Z_0(Z_0 + Z_a) \end{pmatrix}$$

with: $\Delta = Z_0(Z_0 + Z_a) + Z_b(2Z_0 + Z_a)$

$S_{12} = S_{21} \wedge S_{11} \neq S_{22} \Rightarrow$ reciprocal, but not symmetric

- **Without prof: The S-matrix is always symmetric for reciprocal networks.**

2-port series-network



$$(S_{ser}) = \frac{1}{2Z_0 + Z} \begin{pmatrix} Z & 2Z_0 \\ 2Z_0 & Z \end{pmatrix}$$

$$S_{11} = S_{22} \wedge S_{12} = S_{21}$$

4-port ideal directional coupler

$$(S_{dc}) = \frac{1}{2} \begin{pmatrix} 0 & \sqrt{3} & j & 0 \\ \sqrt{3} & 0 & 0 & j \\ j & 0 & 0 & \sqrt{3} \\ 0 & j & \sqrt{3} & 0 \end{pmatrix}$$

$$Z = j\omega L = j10$$

$$Z = R = 10$$

$$|S_{11}| = \sqrt{1 - |S_{12}|^2}$$

$$\frac{1}{\sqrt{101}} = \sqrt{1 - \left(\frac{10}{\sqrt{101}}\right)^2}$$

$$\frac{1}{11} \neq \sqrt{1 - \left(\frac{10}{11}\right)^2}$$

$$\angle S_{11} - \angle S_{12} = \angle S_{21} - \angle S_{22} - \pi$$

$$\tan^{-1}(10) + \tan^{-1}\frac{1}{10} = -\tan^{-1}\frac{1}{10} - \tan^{-1}(10) - \pi$$

$$0 - 0 \neq 0 - 0 - \pi$$

⇒ lossless

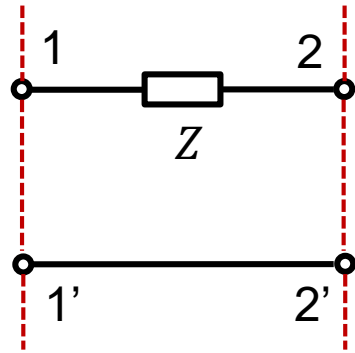
⇒ lossy

- It is evident, this ideal 4-port coupler is symmetric and reciprocal

$$S_{ij} = S_{ji} \wedge S_{ii} = S_{jj}$$

- It also is matched: $S_{ii} = 0$
- But is it lossless or lossy?

2-port series-network



$$(S_{ser}) = \frac{1}{2Z_0 + Z} \begin{pmatrix} Z & 2Z_0 \\ 2Z_0 & Z \end{pmatrix}$$

$$S_{11} = S_{22} \wedge S_{12} = S_{21}$$

$$Z = j\omega L = j10$$

$$Z = R = 10$$

$$|S_{11}| = \sqrt{1 - |S_{12}|^2}$$

$$\frac{1}{\sqrt{101}} = \sqrt{1 - \left(\frac{10}{\sqrt{101}}\right)^2}$$

$$\frac{1}{11} \neq \sqrt{1 - \left(\frac{10}{11}\right)^2}$$

$$\angle S_{11} - \angle S_{12} = \angle S_{21} - \angle S_{22} - \pi$$

$$\tan^{-1}(10) + \tan^{-1}\frac{1}{10} = -\tan^{-1}\frac{1}{10} - \tan^{-1}(10) - \pi$$

$$0 - 0 \neq 0 - 0 - \pi$$

⇒ lossless

⇒ lossy

4-port ideal directional coupler

$$(S_{dc}) = \frac{1}{2} \begin{pmatrix} 0 & \sqrt{3} & j & 0 \\ \sqrt{3} & 0 & 0 & j \\ j & 0 & 0 & \sqrt{3} \\ 0 & j & \sqrt{3} & 0 \end{pmatrix}$$

$$(S)^\dagger(S) = (I) \Rightarrow \sum_{k=1}^N S_{ki}S_{ki}^* = 1 \wedge \sum_{k=1}^N S_{ki}S_{kj}^* = 0 \forall i \neq j$$

- Multiply matrix columns by itself with the conjugate complex
 - and test for = 1

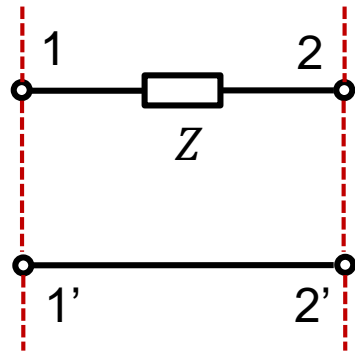
$$S_{11}S_{11}^* + S_{21}S_{21}^* + S_{31}S_{31}^* + S_{41}S_{41}^* = (0 \cdot 0 + \sqrt{3} \cdot \sqrt{3} + j \cdot (-j) + 0 \cdot 0)/2^2 = 1$$

$$S_{12}S_{12}^* + S_{22}S_{22}^* + S_{32}S_{32}^* + S_{42}S_{42}^* = (\sqrt{3} \cdot \sqrt{3} + 0 \cdot 0 + 0 \cdot 0 + j \cdot (-j))/2^2 = 1$$

$$S_{13}S_{13}^* + S_{23}S_{23}^* + S_{33}S_{33}^* + S_{43}S_{43}^* = (j \cdot (-j) + 0 \cdot 0 + 0 \cdot 0 + \sqrt{3} \cdot \sqrt{3})/2^2 = 1$$

$$S_{14}S_{14}^* + S_{24}S_{24}^* + S_{34}S_{34}^* + S_{44}S_{44}^* = (0 \cdot 0 + j \cdot (-j) + \sqrt{3} \cdot \sqrt{3} + 0 \cdot 0)/2^2 = 1$$

2-port series-network



$$(S_{ser}) = \frac{1}{2Z_0 + Z} \begin{pmatrix} Z & 2Z_0 \\ 2Z_0 & Z \end{pmatrix}$$

$$S_{11} = S_{22} \wedge S_{12} = S_{21}$$

$$Z = j\omega L = j10$$

$$Z = R = 10$$

$$|S_{11}| = \sqrt{1 - |S_{12}|^2}$$

$$\frac{1}{\sqrt{101}} = \sqrt{1 - \left(\frac{10}{\sqrt{101}}\right)^2}$$

$$\frac{1}{11} \neq \sqrt{1 - \left(\frac{10}{11}\right)^2}$$

$$\angle S_{11} - \angle S_{12} = \angle S_{21} - \angle S_{22} - \pi$$

$$\tan^{-1}(10) + \tan^{-1}\frac{1}{10} = -\tan^{-1}\frac{1}{10} - \tan^{-1}(10) - \pi$$

$$0 - 0 \neq 0 - 0 - \pi$$

⇒ **lossless**

⇒ **lossy**

4-port ideal directional coupler

$$(S_{dc}) = \frac{1}{2} \begin{pmatrix} 0 & \sqrt{3} & j & 0 \\ \sqrt{3} & 0 & 0 & j \\ j & 0 & 0 & \sqrt{3} \\ 0 & j & \sqrt{3} & 0 \end{pmatrix}$$

$$(S)^\dagger(S) = (I) \Rightarrow \sum_{k=1}^N S_{ki}S_{ki}^* = 1 \wedge \sum_{k=1}^N S_{ki}S_{kj}^* = 0 \forall i \neq j$$

- **Multiply all different matrix columns with the conjugate complex**
 - and test for = 0

$$S_{11}S_{12}^* + S_{21}S_{22}^* + S_{31}S_{32}^* + S_{41}S_{42}^* = (0 \cdot \sqrt{3} + \sqrt{3} \cdot 0 + j \cdot 0 + 0 \cdot (-j))/2^2 = 0$$

$$S_{11}S_{13}^* + S_{21}S_{23}^* + S_{31}S_{33}^* + S_{41}S_{43}^* = (0 \cdot (-j) + \sqrt{3} \cdot 0 + j \cdot 0 + 0 \cdot \sqrt{3})/2^2 = 0$$

$$S_{11}S_{14}^* + S_{21}S_{24}^* + S_{31}S_{34}^* + S_{41}S_{44}^* = (0 \cdot 0 + \sqrt{3} \cdot (-j) + j \cdot \sqrt{3} + 0 \cdot 0)/2^2 = 0$$

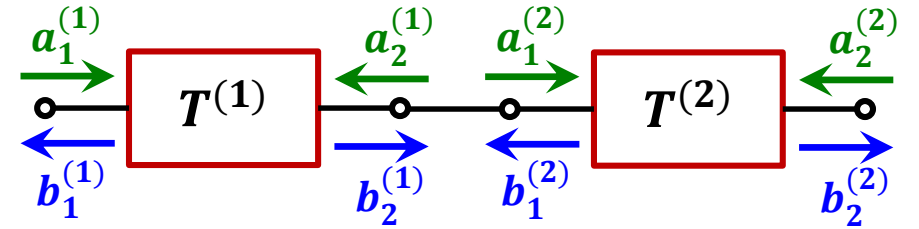
$$S_{12}S_{13}^* + S_{22}S_{23}^* + S_{32}S_{33}^* + S_{42}S_{43}^* = (\sqrt{3} \cdot (-j) + 0 \cdot 0 + 0 \cdot 0 + j \cdot \sqrt{3})/2^2 = 0$$

$$S_{12}S_{14}^* + S_{22}S_{24}^* + S_{32}S_{34}^* + S_{42}S_{44}^* = (\sqrt{3} \cdot 0 + 0 \cdot (-j) + 0 \cdot \sqrt{3} + j \cdot 0)/2^2 = 0$$

$$S_{13}S_{14}^* + S_{23}S_{24}^* + S_{33}S_{34}^* + S_{43}S_{44}^* = (j \cdot 0 + 0 \cdot (-j) + 0 \cdot \sqrt{3} + \sqrt{3} \cdot 0)/2^2 = 0$$

- Cascading e.g., 2-port S-parameter files is important to characterize a larger RF system.
 - Solution: Transfer (T) parameters, which directly relates the waves at input and output

$$(T) = \begin{pmatrix} T_{11} & T_{12} \\ T_{12} & T_{22} \end{pmatrix} \Rightarrow \begin{aligned} b_1 &= T_{11}a_2 + T_{12}b_2 \\ a_1 &= T_{21}a_2 + T_{22}b_2 \end{aligned}$$



- T-parameters enable cascaded 2-port networks by simply multiplying their matrices:

$$(T) = (T^{(1)})(T^{(2)}) \dots (T^{(N)}) = \prod_{i=1}^N (T^{(i)})$$

- Relation between 2-port **T-parameters** and **S-parameters**:

$$(T) = \frac{1}{S_{21}} \begin{pmatrix} -\det(S) & S_{11} \\ -S_{22} & 1 \end{pmatrix}$$

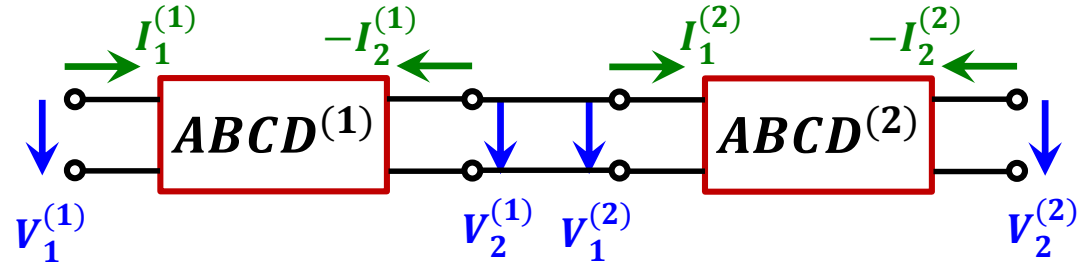
with: $\det(S) = S_{11}S_{22} - S_{12}S_{21}$

$$(S) = \frac{1}{T_{22}} \begin{pmatrix} T_{12} & \det(T) \\ 1 & -T_{21} \end{pmatrix}$$

with: $\det(T) = T_{11}T_{22} - T_{12}T_{21}$

- Also called “chain” parameters, used for cascading networks based on V and I
 - Useful for chaining a mix of lumped elements and transmission-lines

$$(ABCD) = \begin{pmatrix} A & B \\ C & D \end{pmatrix} \Rightarrow \begin{aligned} V_1 &= AV_2 - BI_2 \\ I_1 &= CV_2 - DI_2 \end{aligned}$$



- Chaining 2-port ABCD-parameter networks:

$$(ABCD) = (ABCD^{(1)})(ABCD^{(2)}) \dots (ABCD^{(N)}) = \prod_{i=1}^N (ABCD^{(i)})$$

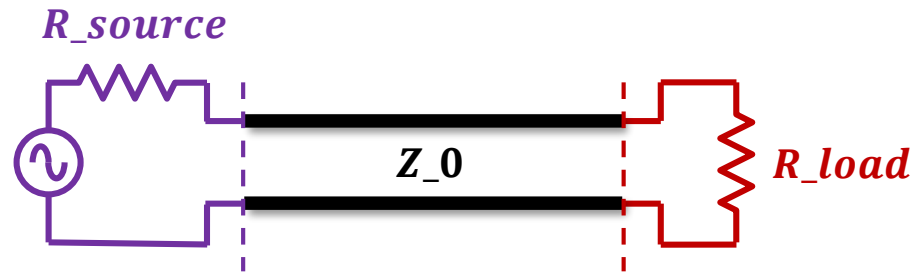
- Relation between 2-port **ABCD-parameters** and **S-parameters**:

$$S_{11} = \frac{A + B/Z_0 - CZ_0 - D}{A + B/Z_0 + CZ_0 + D}$$

$$S_{12} = \frac{2(AD - BC)}{A + B/Z_0 + CZ_0 + D}$$

$$S_{21} = \frac{2}{A + B/Z_0 + CZ_0 + D}$$

$$S_{22} = \frac{-A + B/Z_0 - CZ_0 + D}{A + B/Z_0 + CZ_0 + D}$$



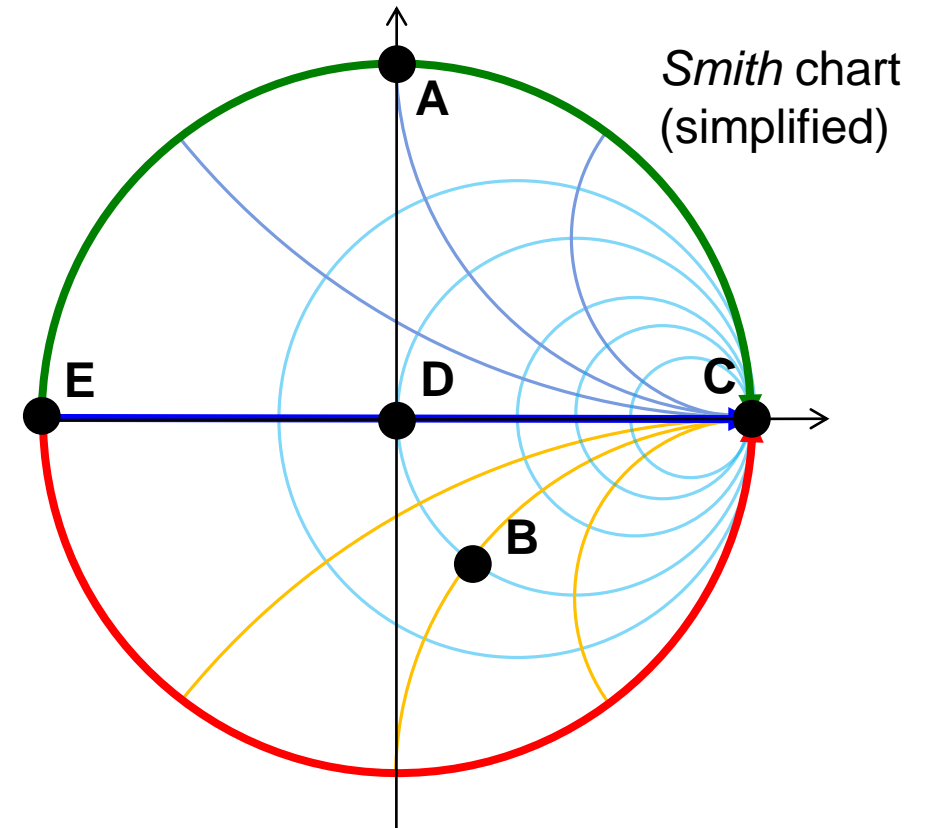
1. When do no signal reflections occur at the end of a transmission-line?

- $R_source = R_load$
- $R_source = Z_0$
- $Z_0 = R_load$
- $R_source = Z_0 = R_load$

2. The Smith chart transforms the complex impedance plane onto the complex Gamma (reflection coefficient) plane within the unit circle.

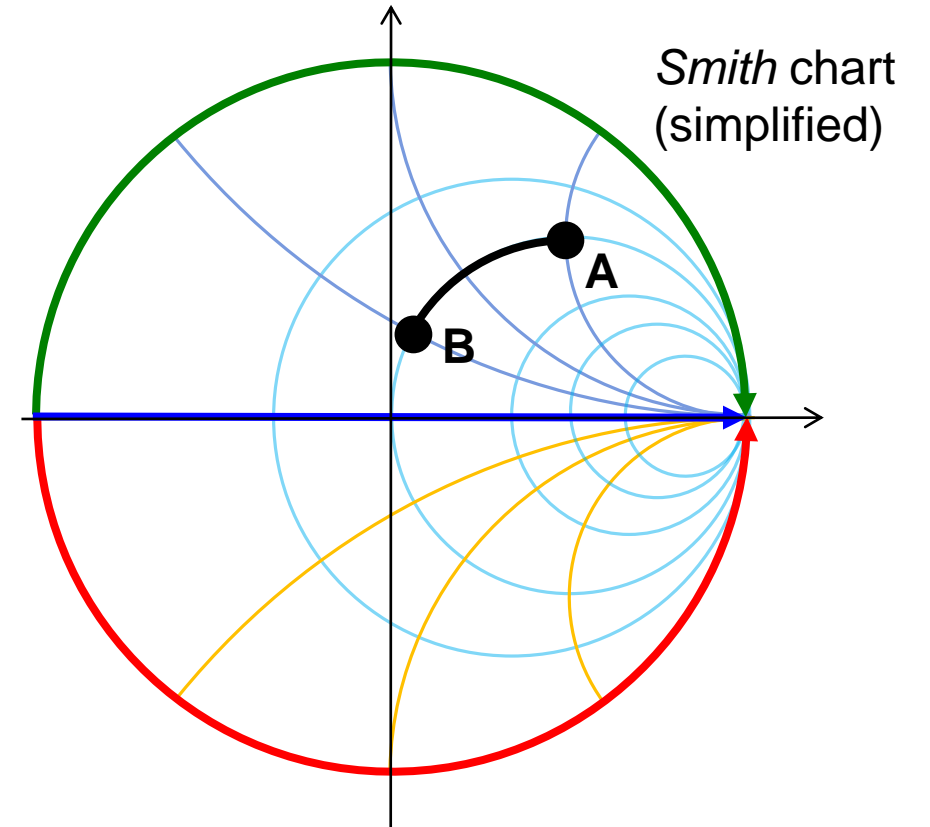
Quiz (2)

Prompts		Possible Answers
A. Point A	A5	1. $\Gamma = +1, z \rightarrow \infty$
B. Point B	B4	2. $\Gamma = -j$
C. Point C	C1	3. $\Gamma = 0, z = 1, \text{ match}$
D. Point D	D3	4. Point in the capacitive half plane
E. Point E	E6	5. $\Gamma = +j$
		6. $\Gamma = -1, z = 0$
		7. Point in the inductive half plane



4. Trace with marker points in the simplified Smith chart for an RL series impedance

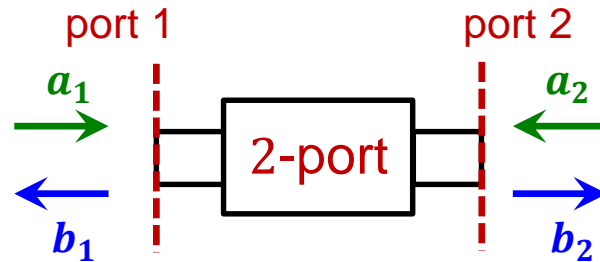
- Frequency f at point B $>$ frequency f at point A
- Frequency f at point B $<$ frequency f at point A
- There is no frequency related to points A and B
- Frequency f at point A = frequency f at point B



1. Select all correct answers

- Y- and Z-parameters of electrical networks require a reference impedance Z_0
- Scattering parameters of RF networks are based on normalize complex voltage waves incident and reflected / transmitted at their ports
- DUT stands for “Device Under Test”, as acronym for the RF network to be characterized
- S-parameters are only defined for a reference impedance of $Z_0 = 50 \text{ Ohm}$.
- Unused ports in a S-parameter measurement setup always need to be terminated in their characteristic port impedance

Prompts		Possible Answers
A. matched	A4	1. $S_{ii} = S_{ij}$
B. symmetric	B3	2. $(S^*)^T = (i)$
C. reciprocal	C5	3. $S_{ij} = S_{ji}$ and $S_{ii} = S_{jj}$
D. passive and lossless	D2	4. $S_{ii} = 0$
		5. $\Gamma = +j$
		6. $S_{ij} = S_{ji}$



3. Mark all correct answers for the S-parameters of a 2-port RF network

- a_1 and b_1 are independent parameters
- S_{11} is the input reflection coefficient
- a_1 and a_2 are the incident waves at port 1 and port 2, respectively.
- b_1 and b_2 are the transmitted waves between port 1 and port 2, and vice versa.
- S_{21} and S_{12} are the forward and reverse transmission gains.
- To characterize the S-parameters at port 2, port 1 needs to be terminated in its characteristic port impedance.